

FIG. 1

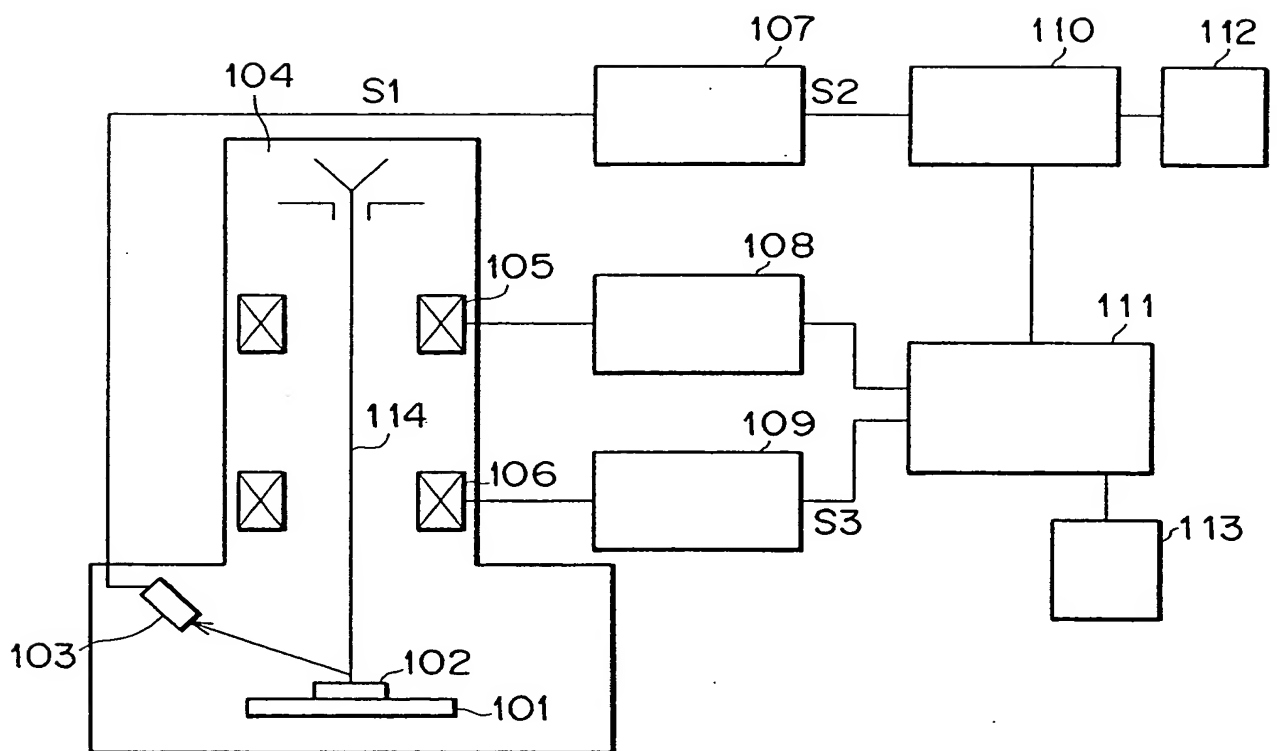


FIG. 2

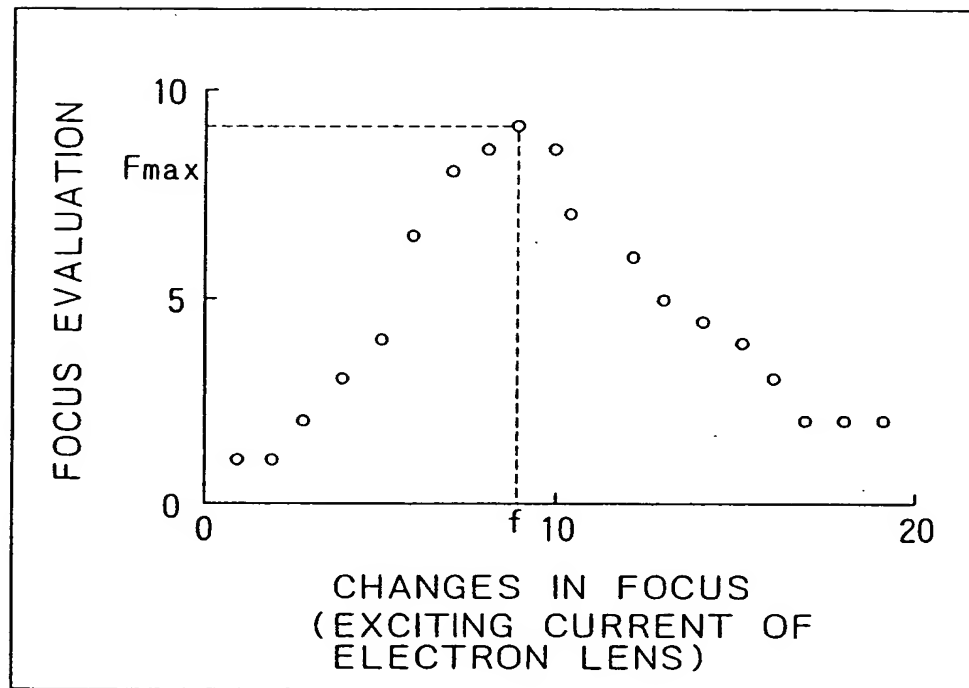


FIG. 3

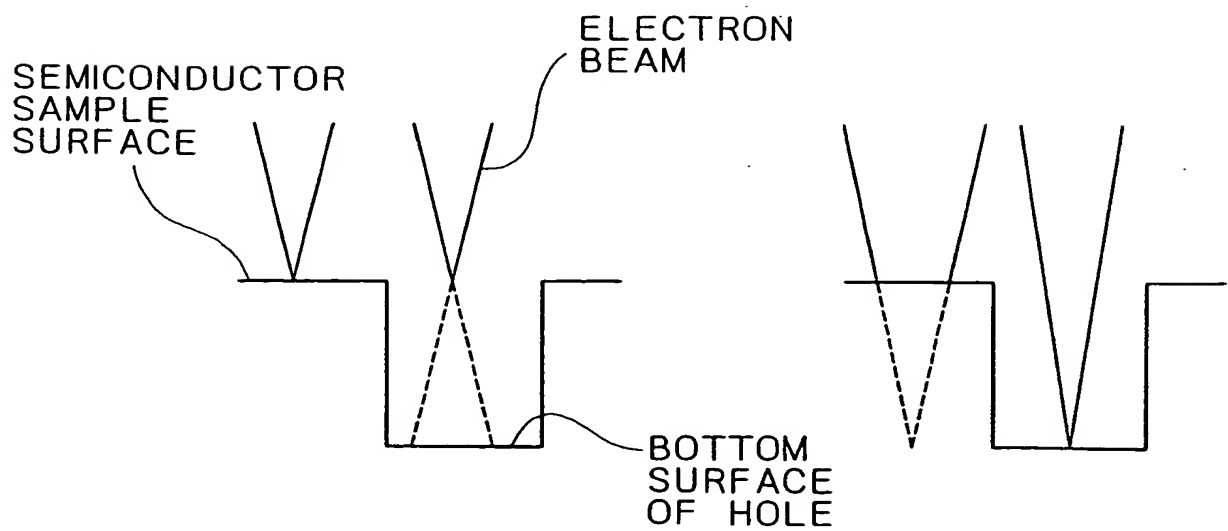


FIG. 4

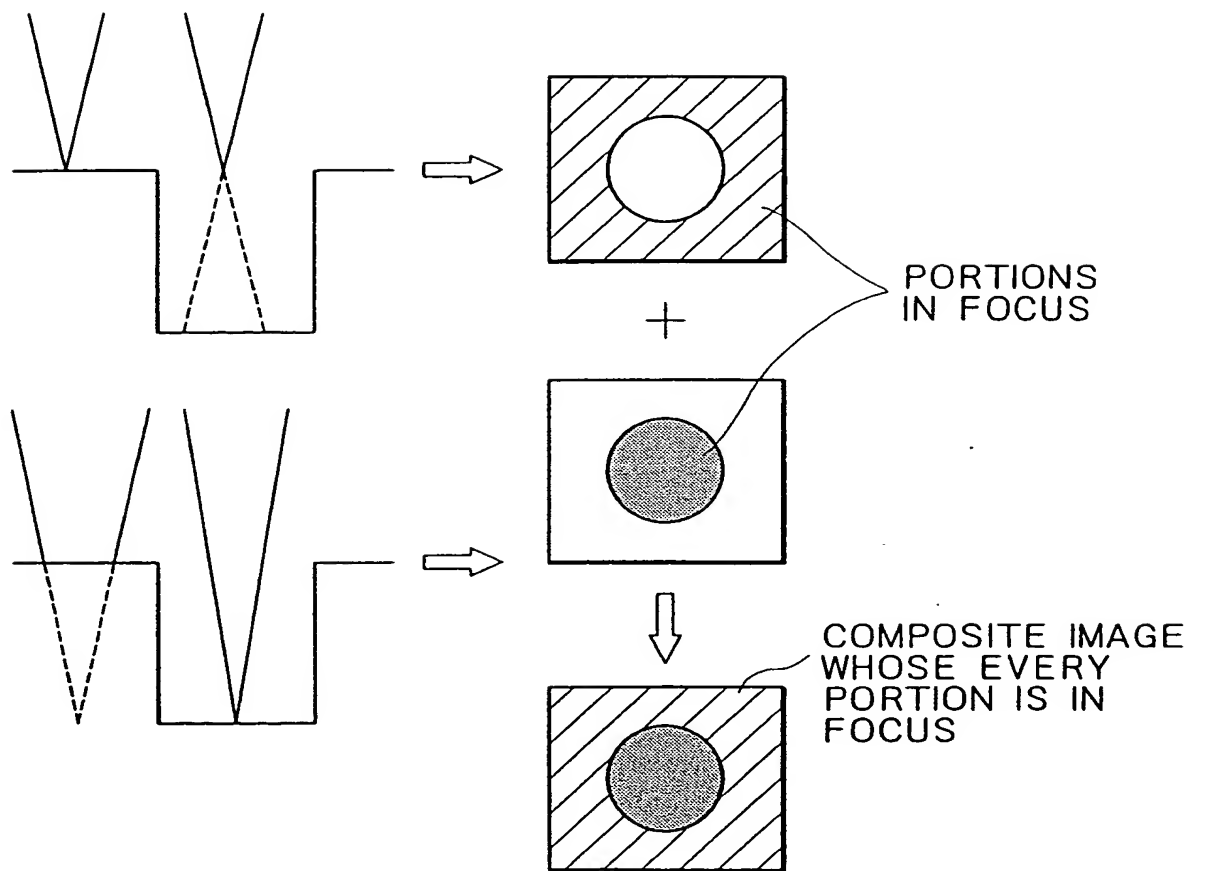


FIG. 5

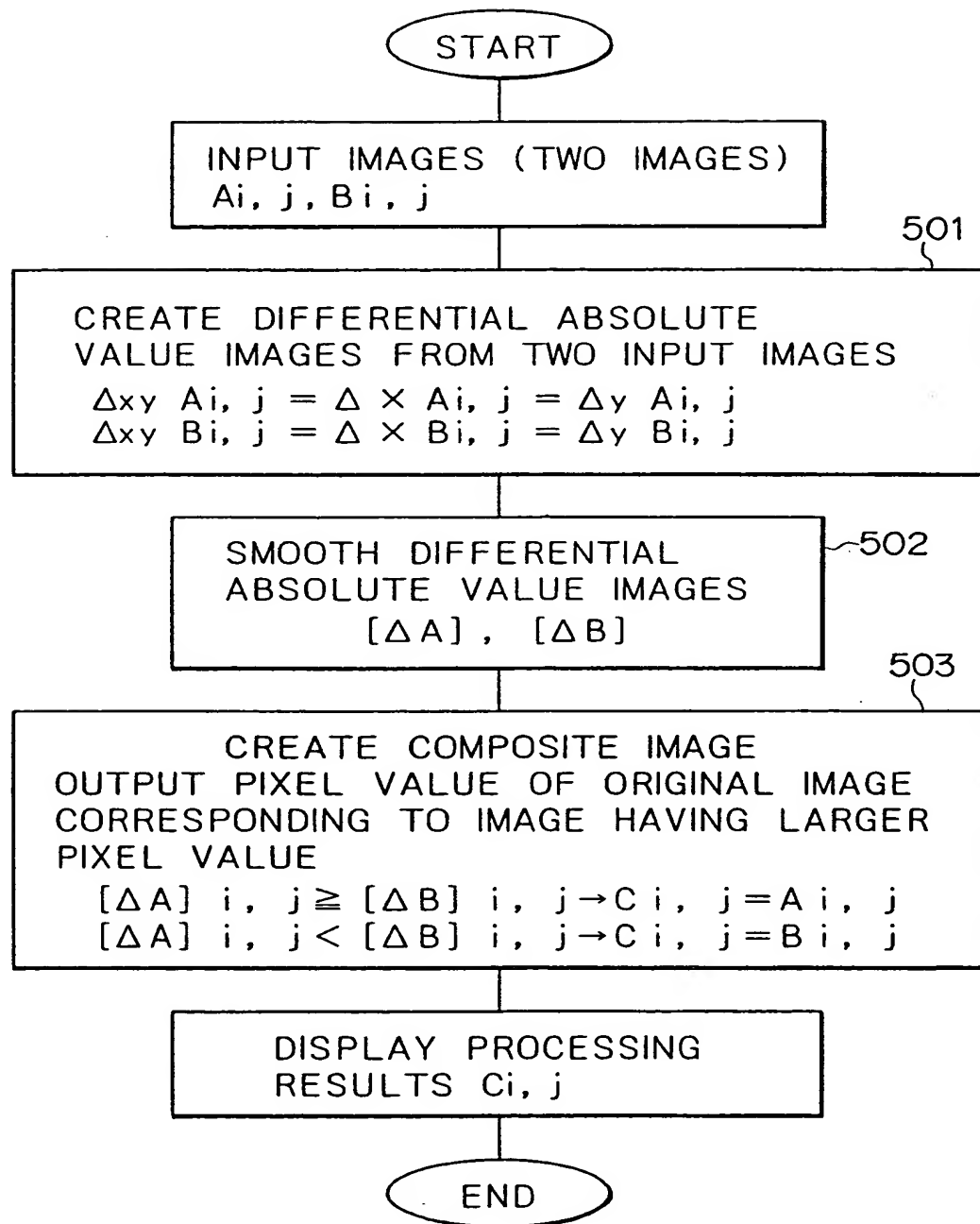


FIG. 6

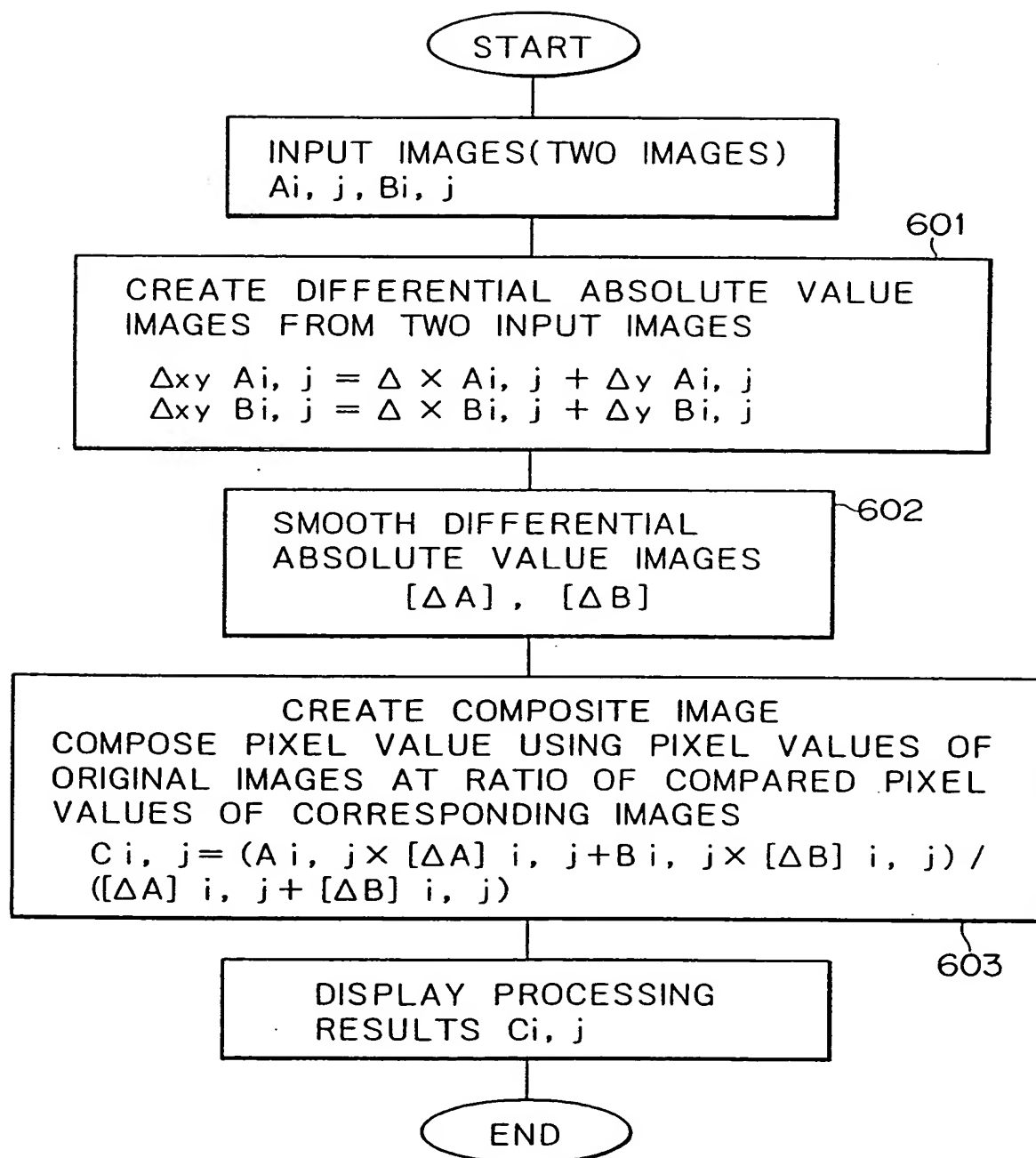


FIG. 7

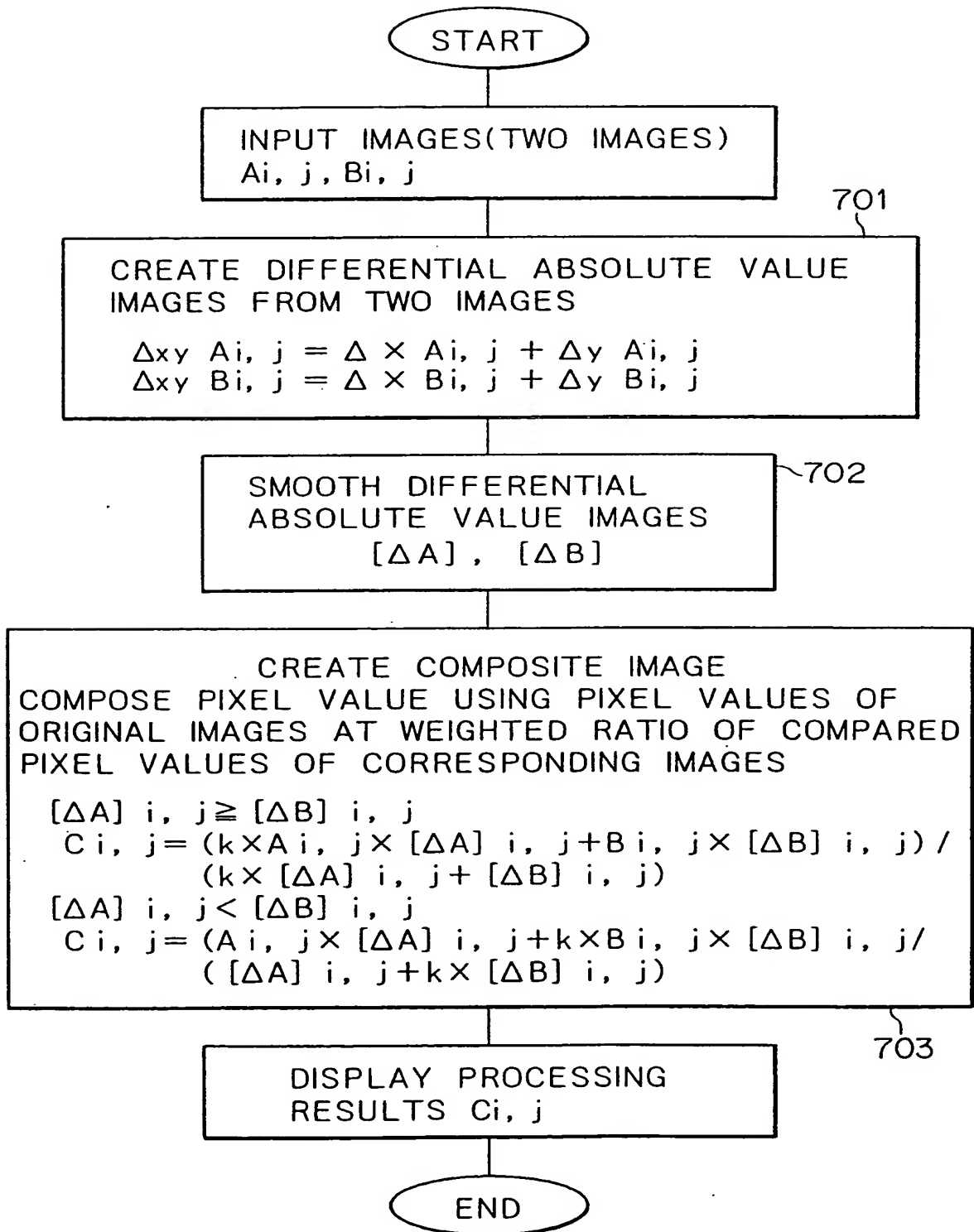
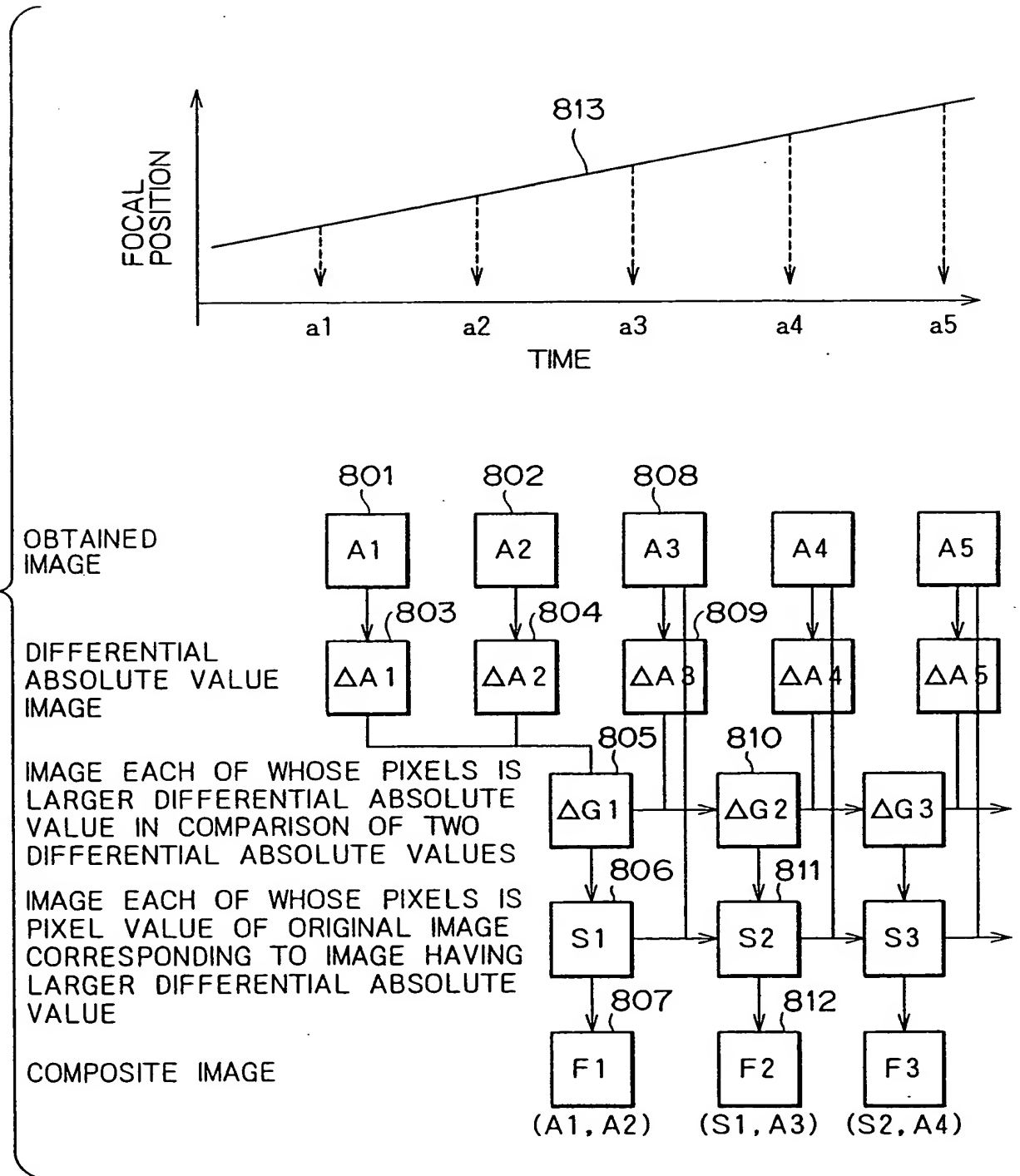
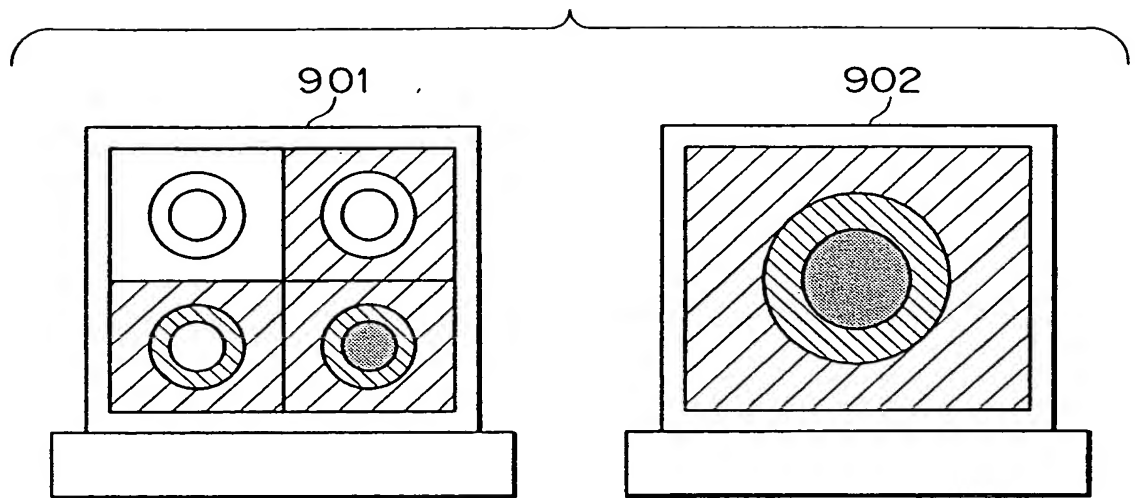


FIG. 8



F I G . 9



F I G . 10

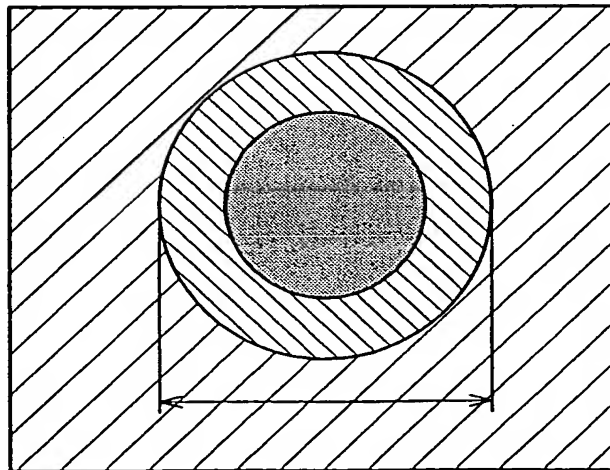


FIG.11

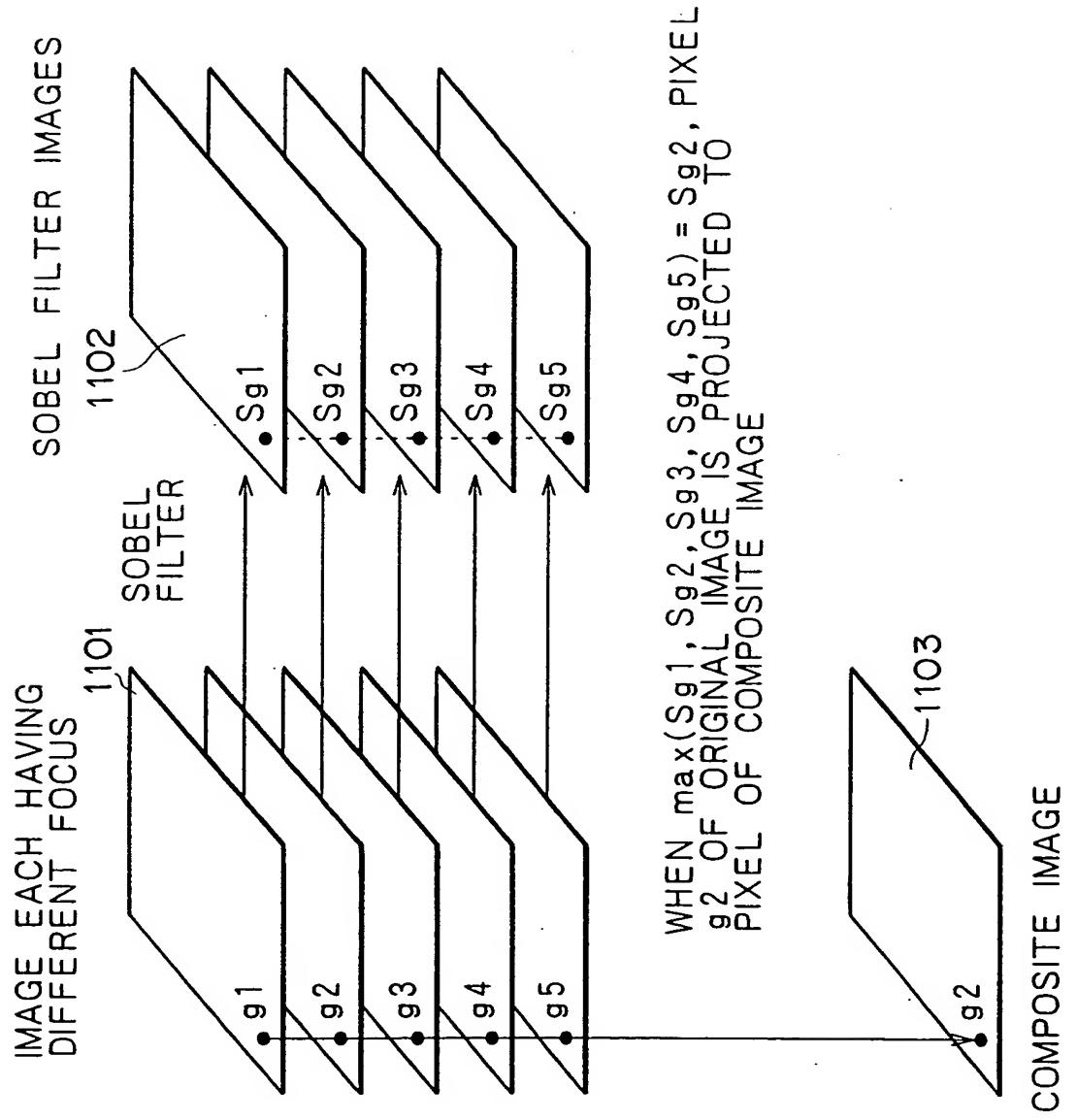


FIG. 12

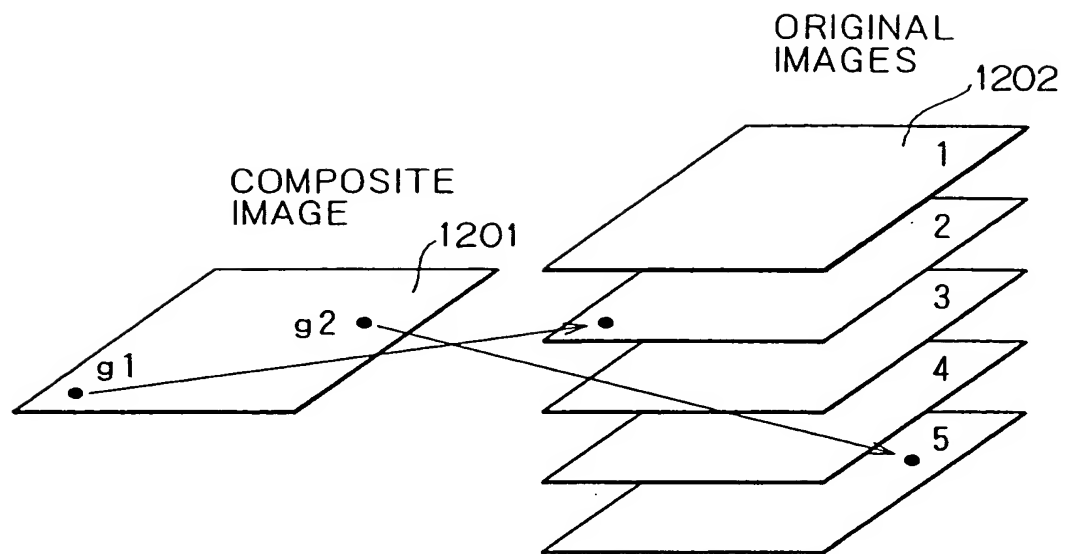


FIG. 13

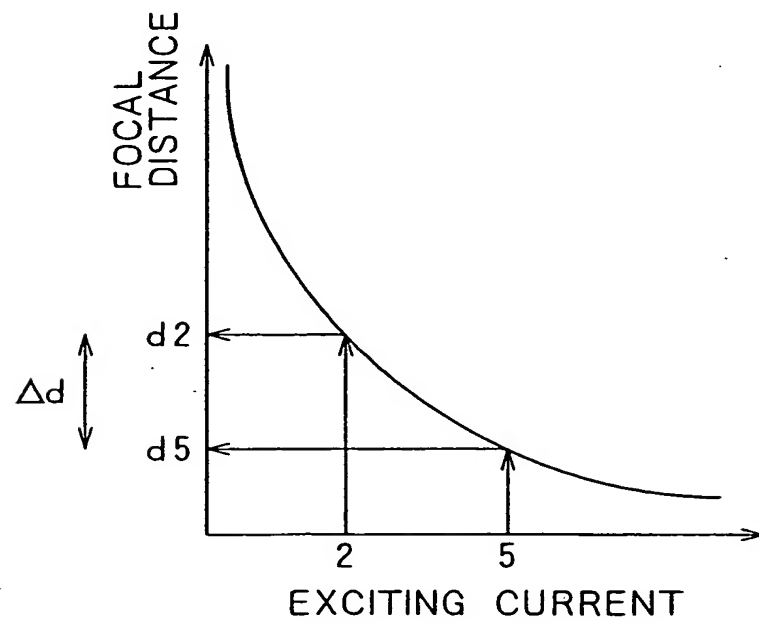


FIG.14

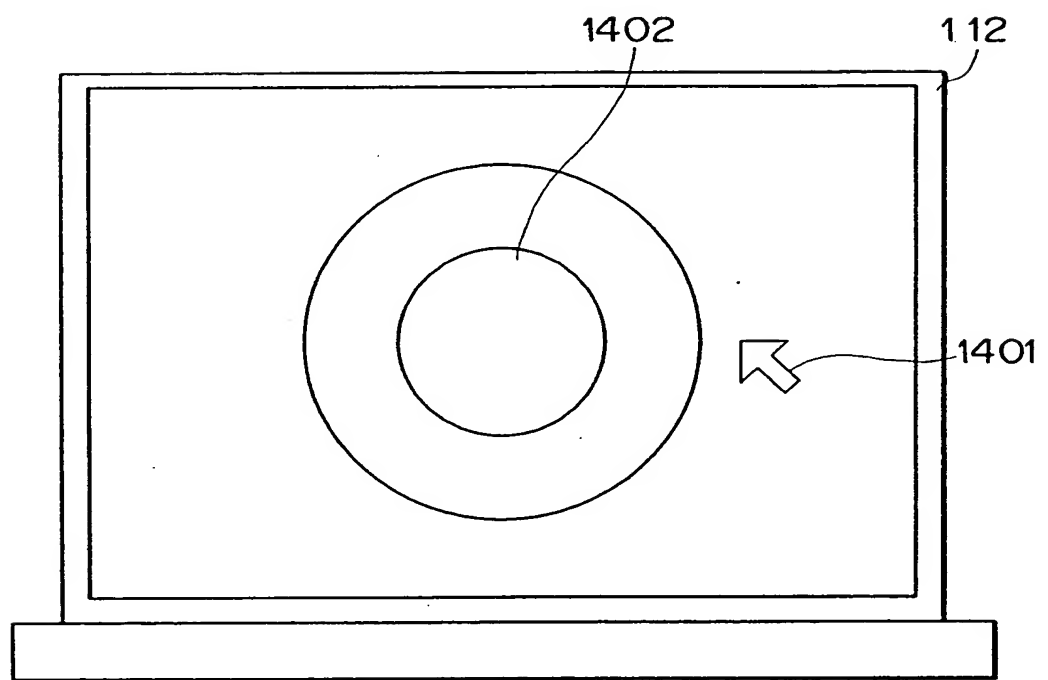


FIG. 15

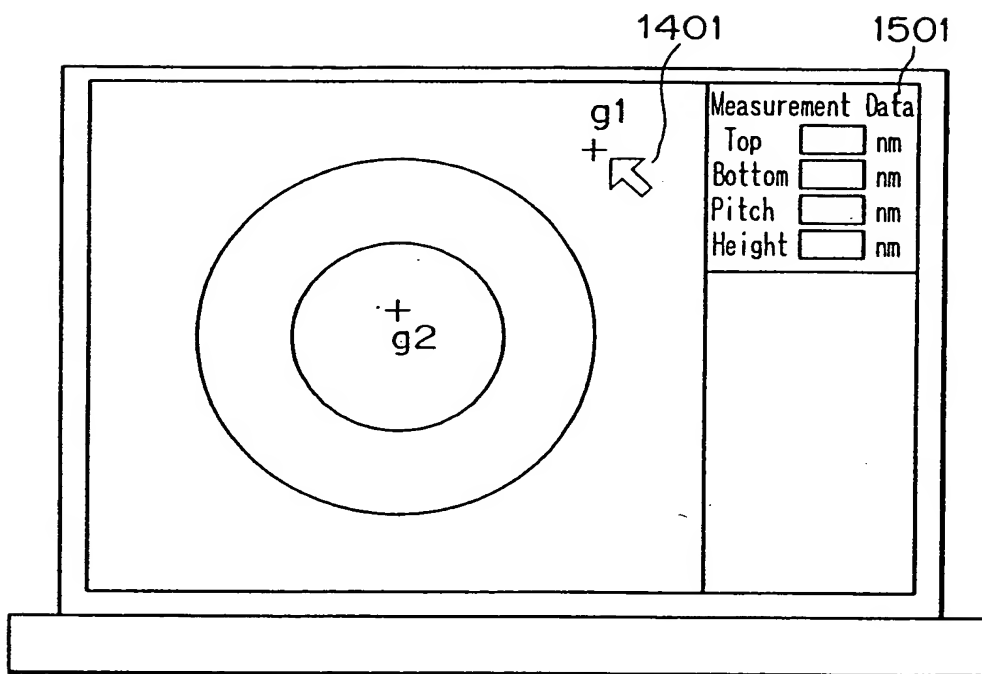


FIG. 16

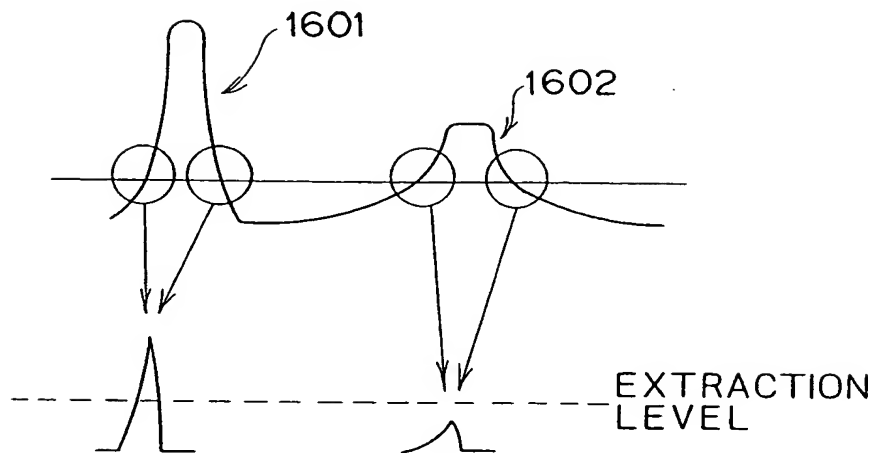


FIG. 17

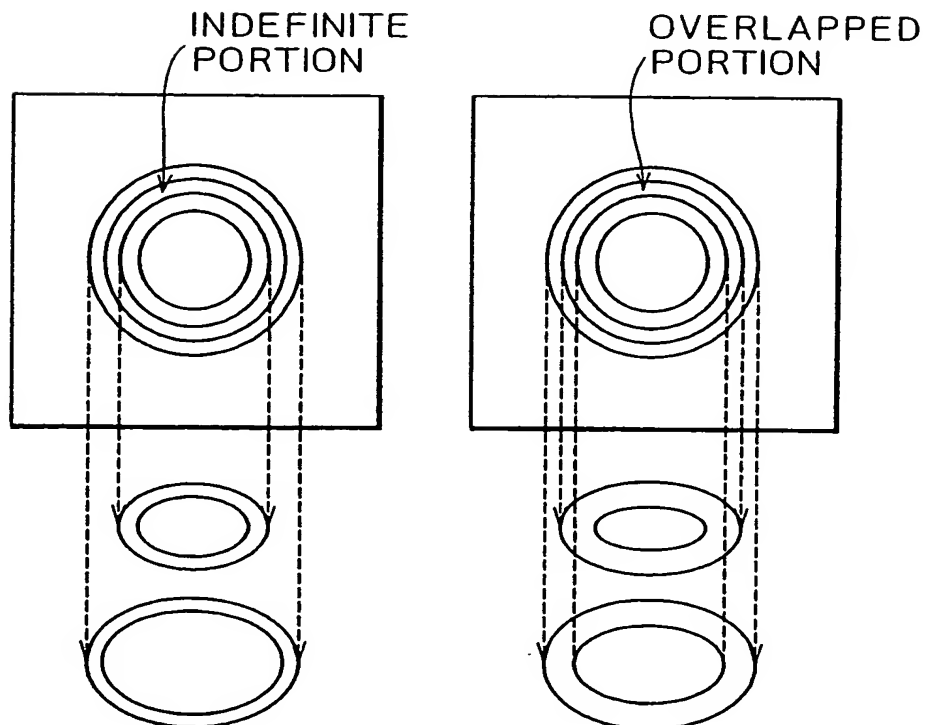


FIG. 18

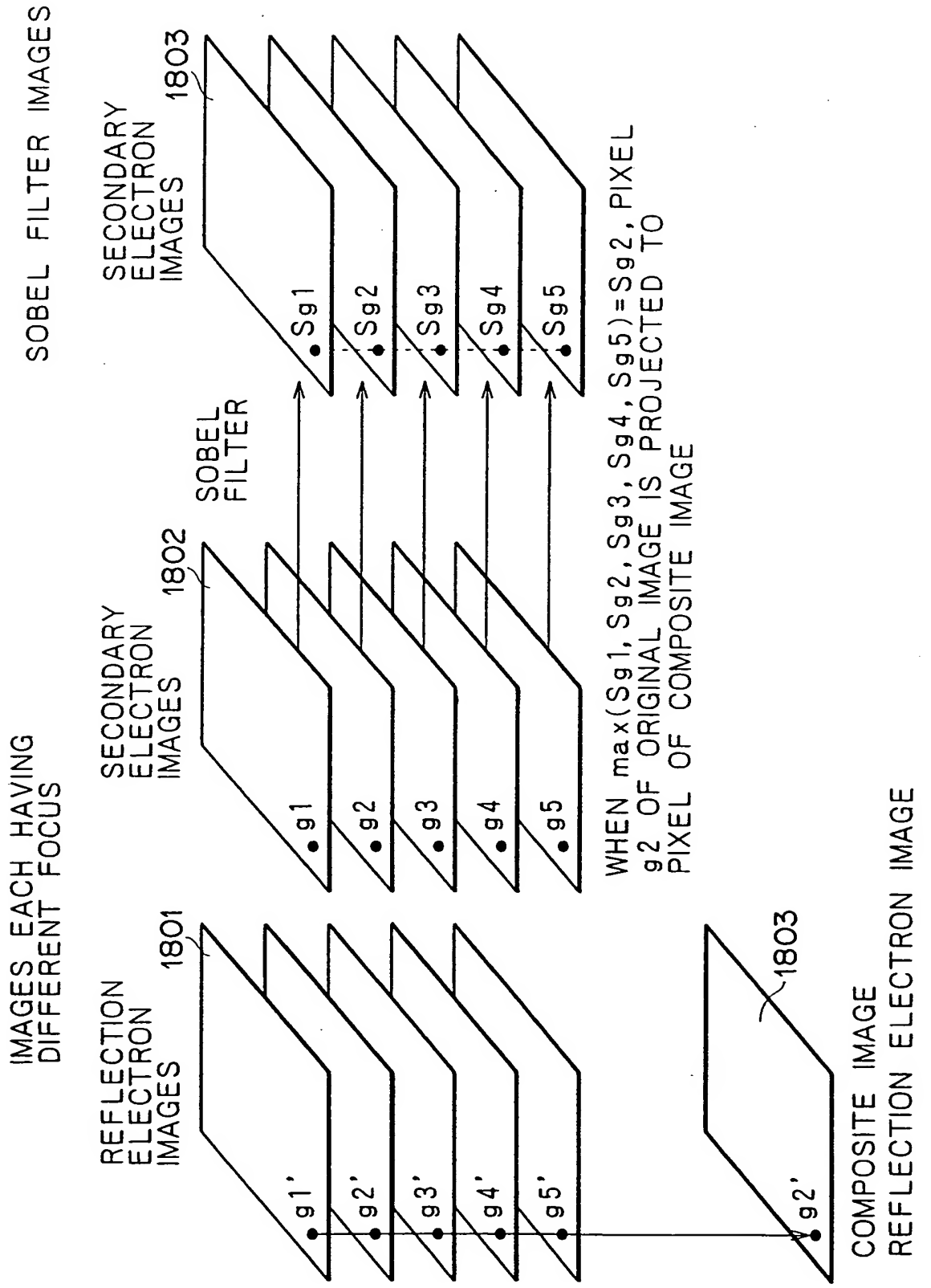
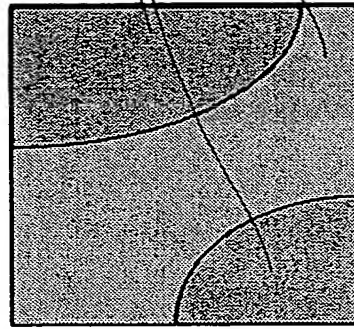


FIG. 19

AREAS WHOSE IN-FOCUS DEGREE
IS DETERMINED USING REFLECTION
ELECTRON IMAGES



AREA WHOSE IN-FOCUS DEGREE
IS DETERMINED USING SECONDARY
ELECTRON IMAGES

FIG. 20

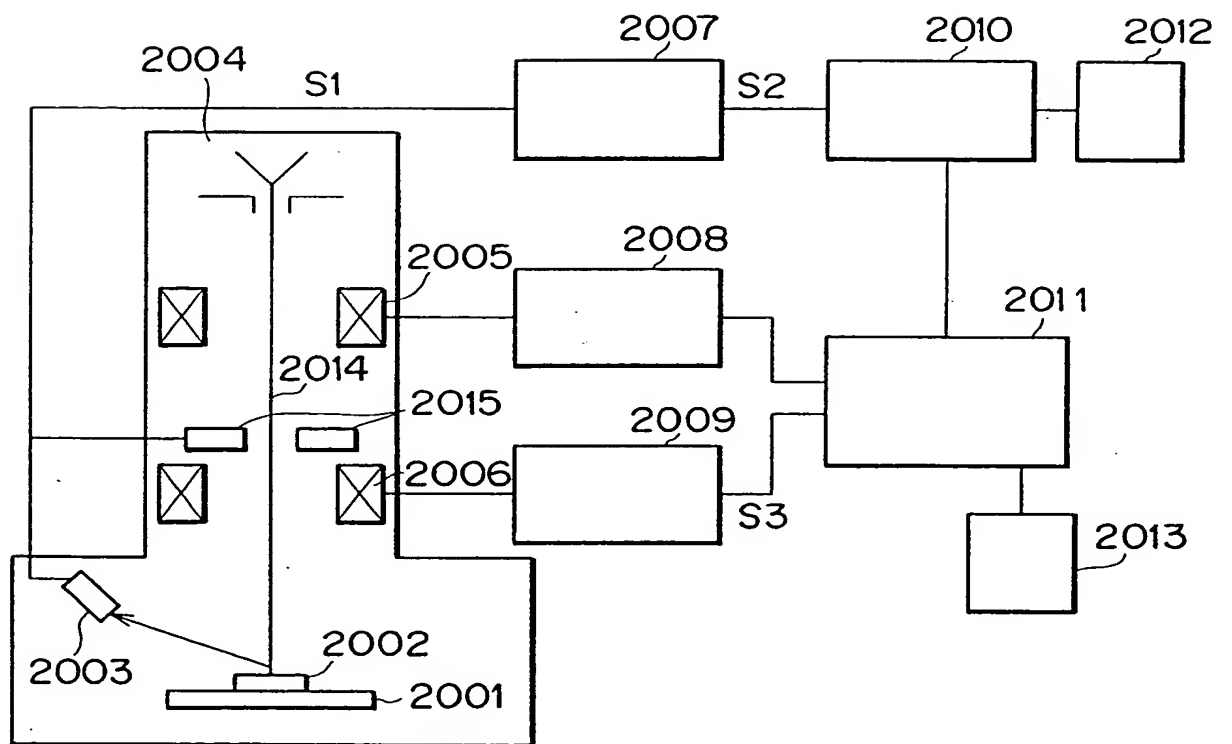
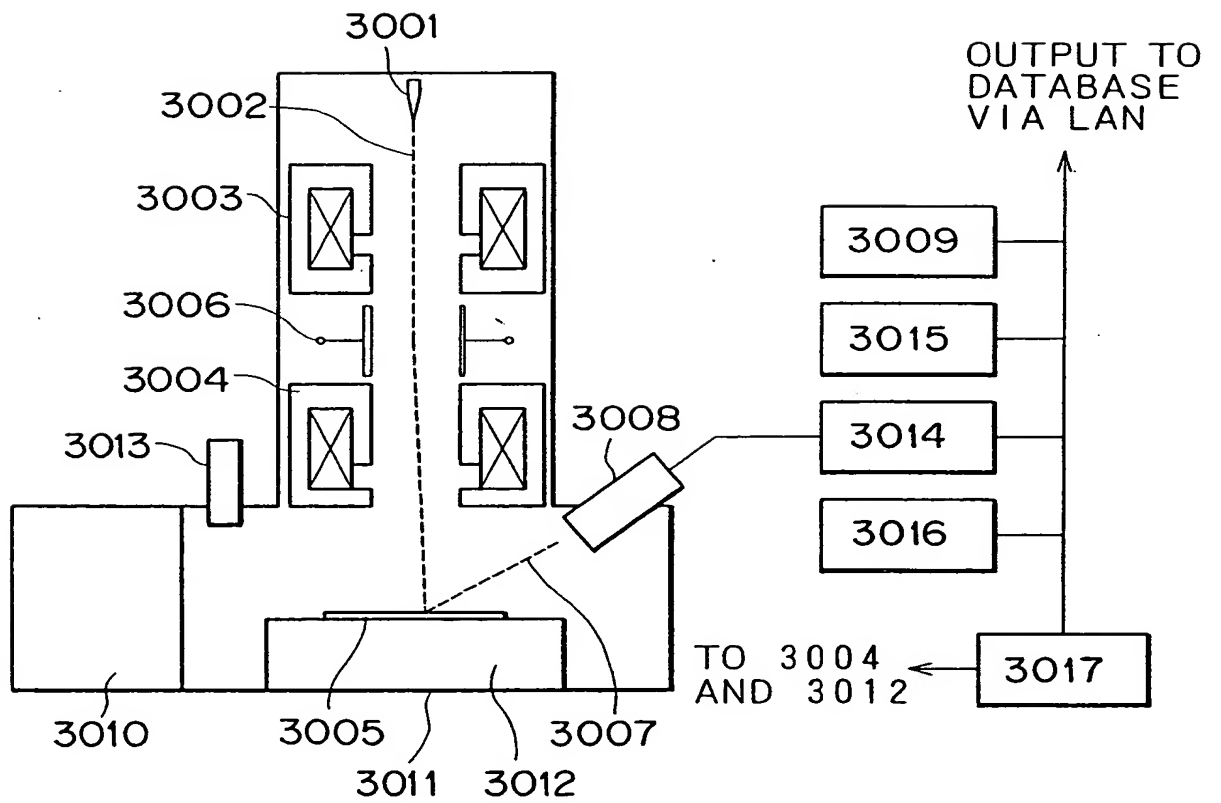


FIG. 21



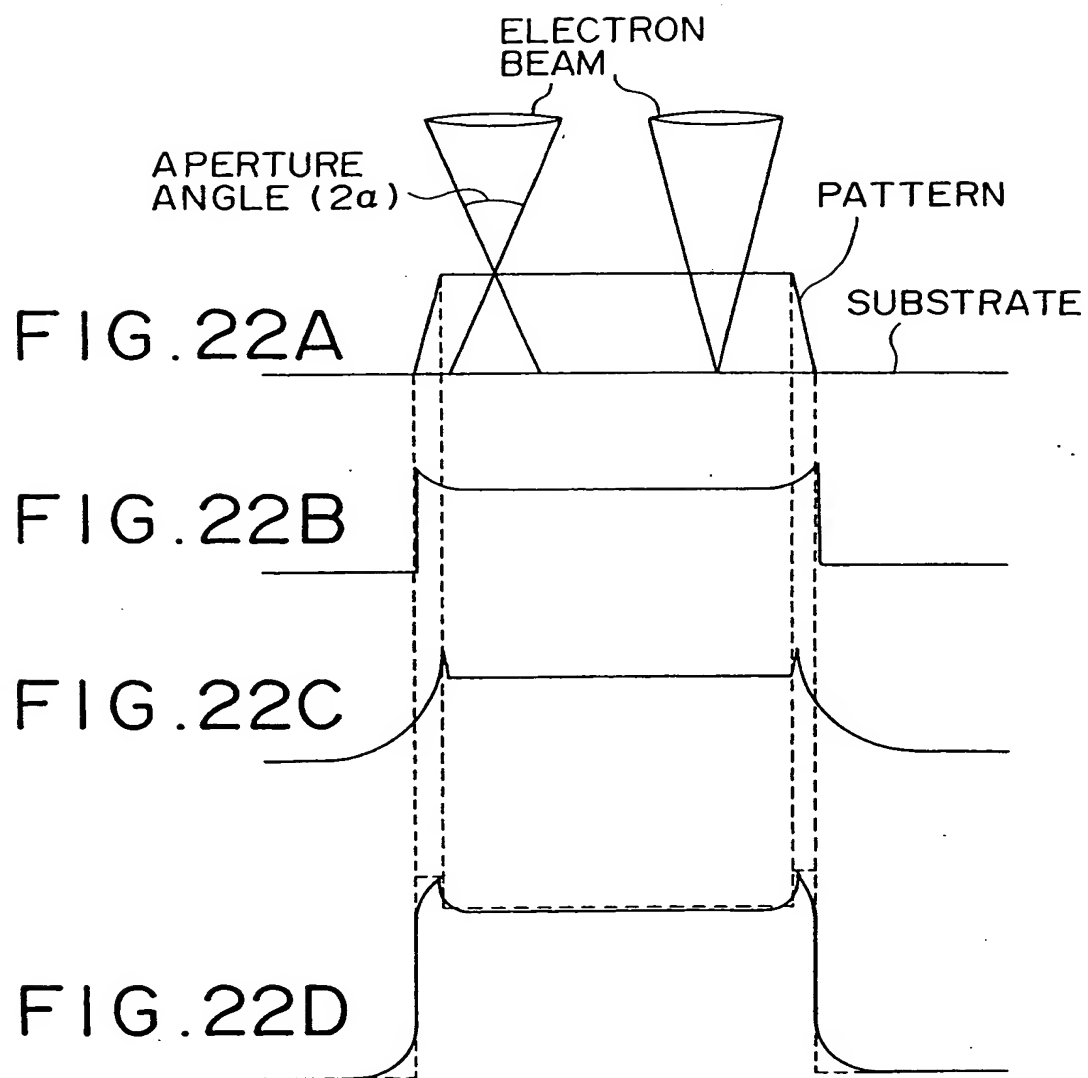


FIG. 23

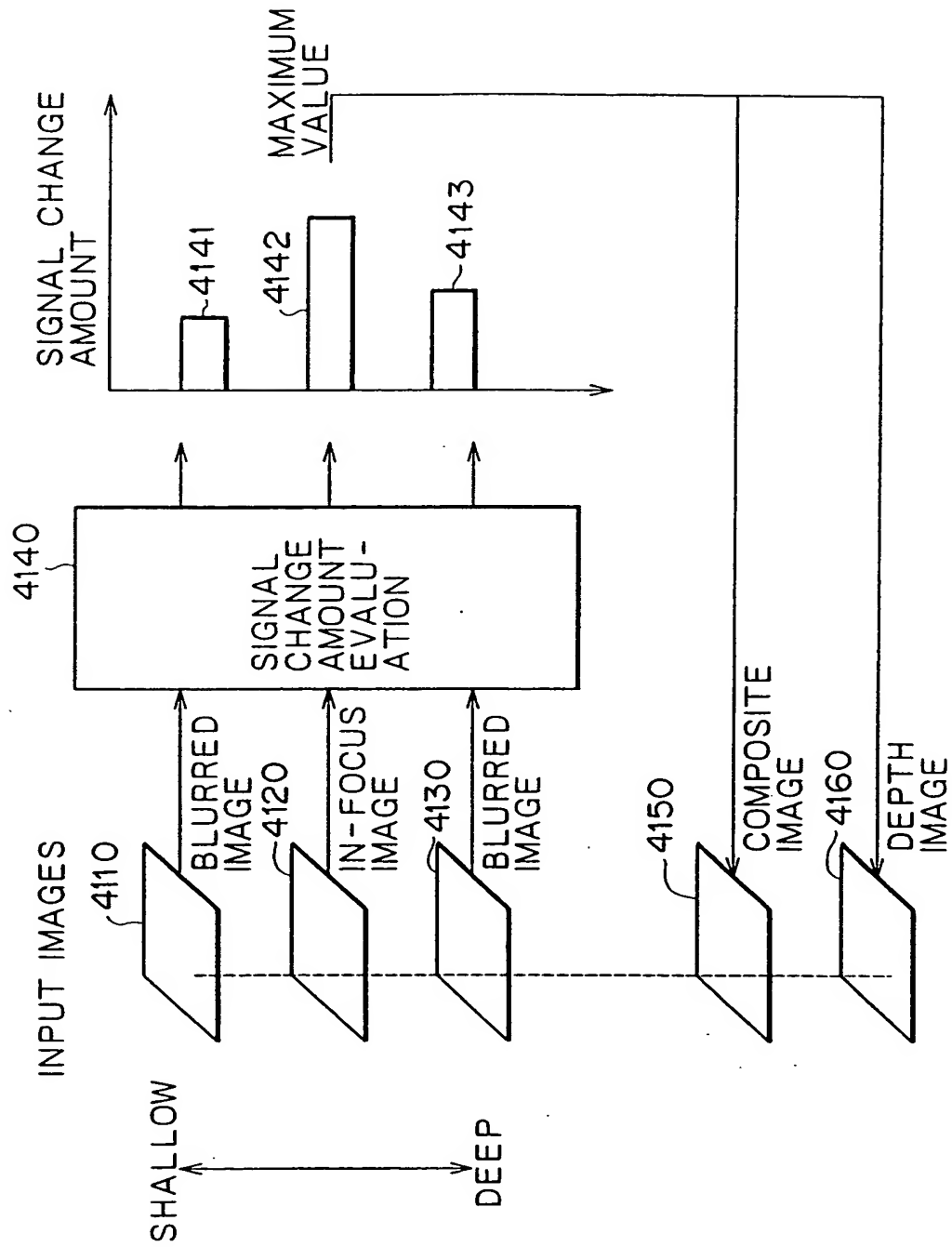


FIG. 24

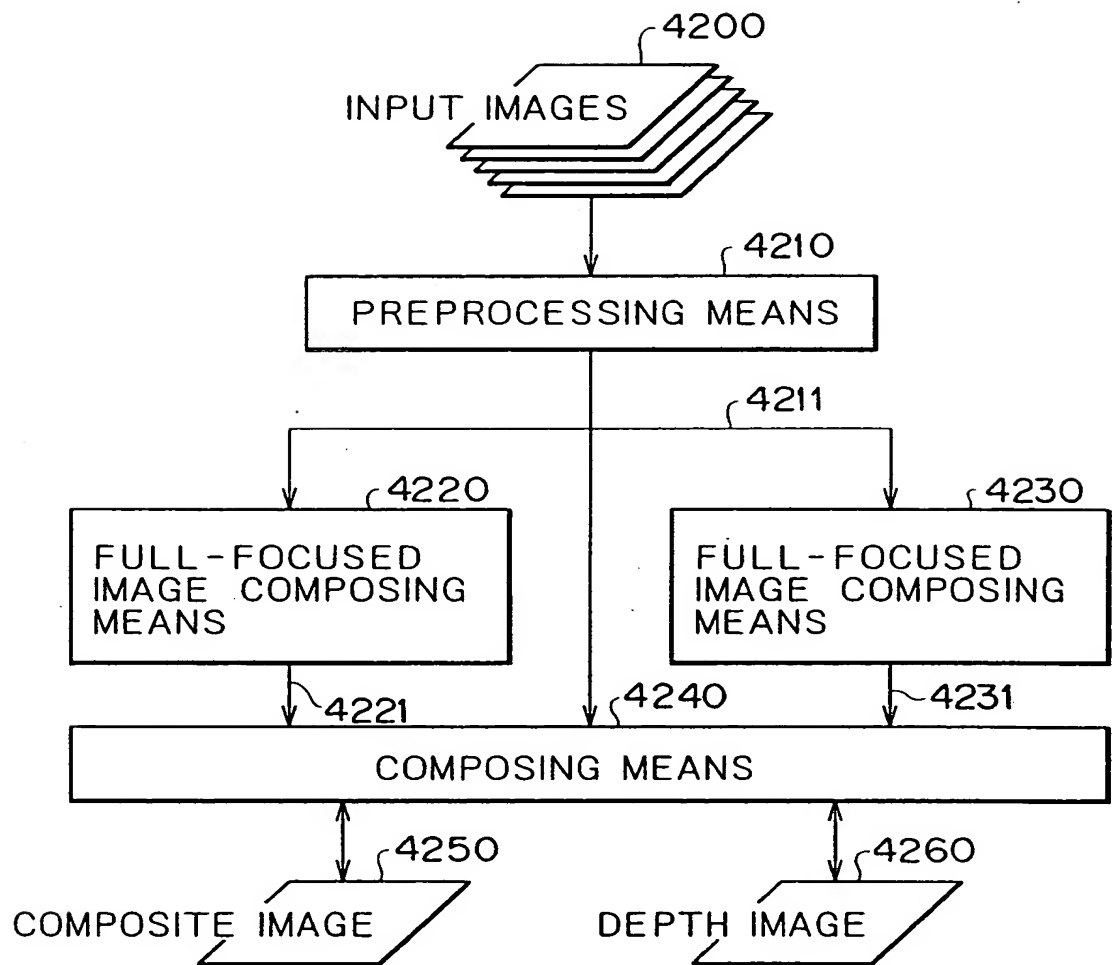


FIG. 25

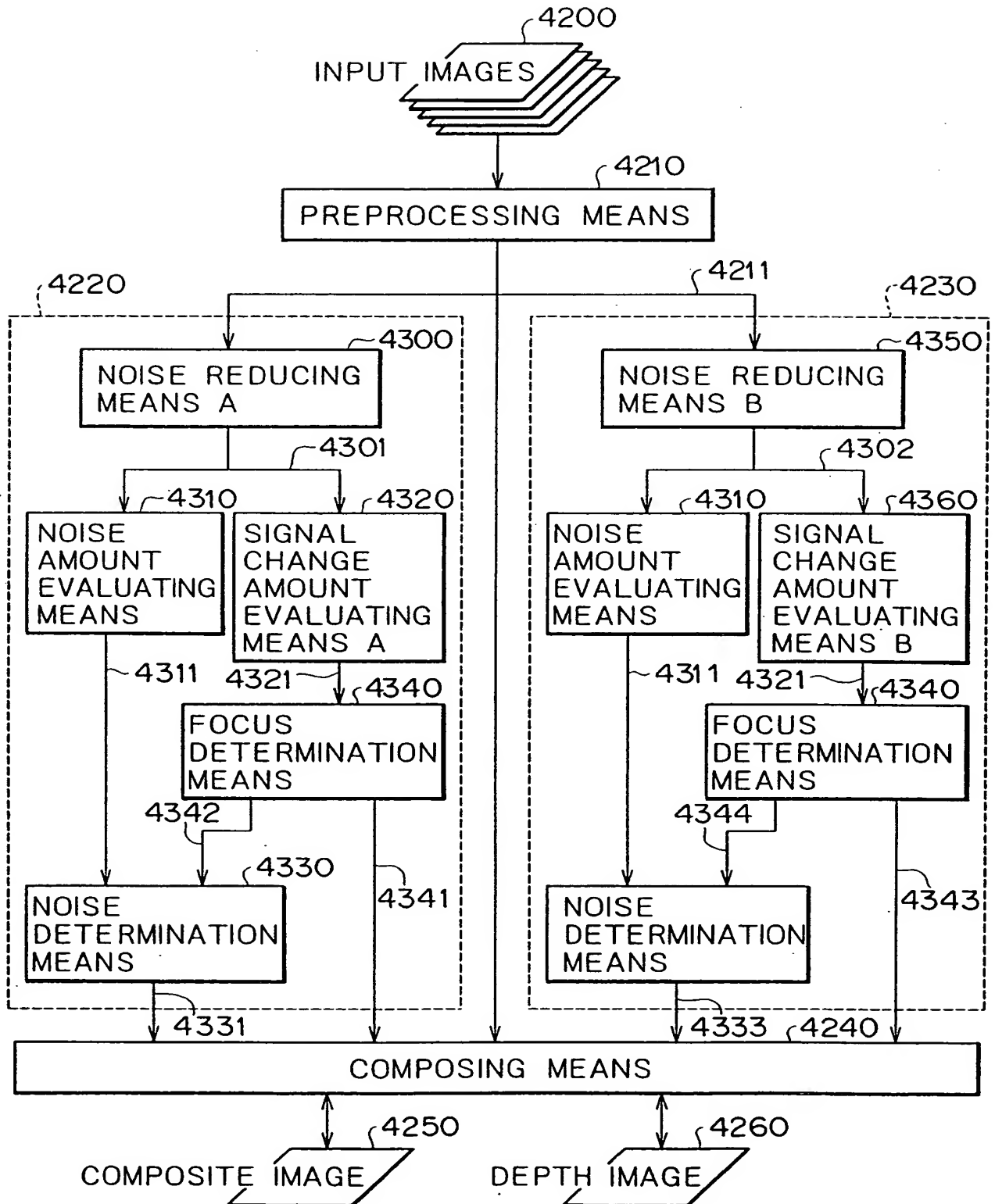


FIG. 26

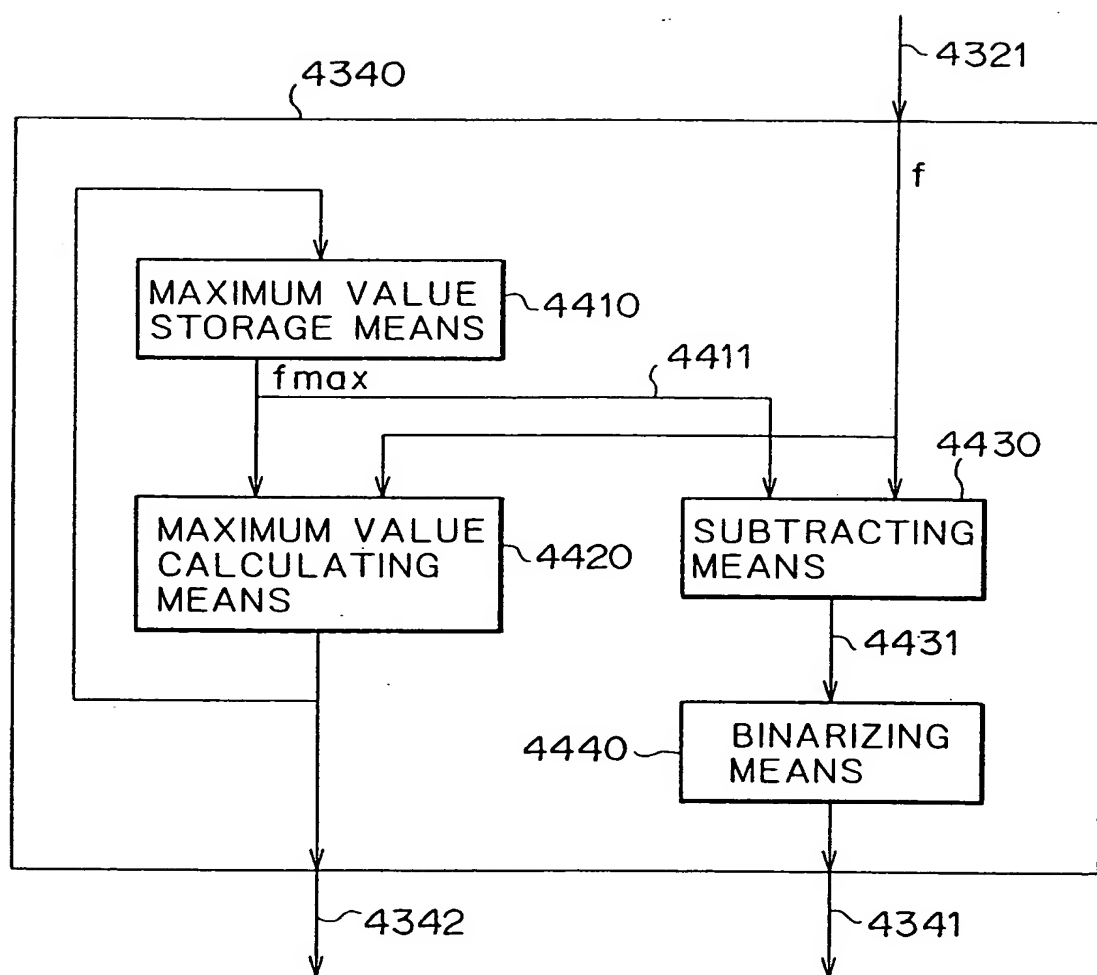


FIG. 27

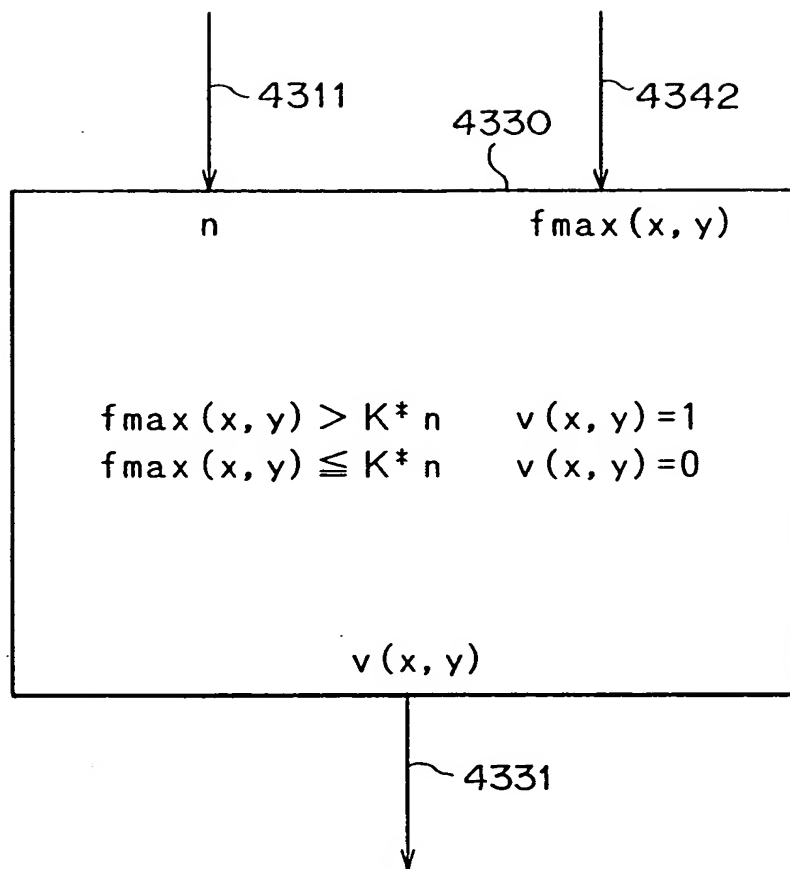
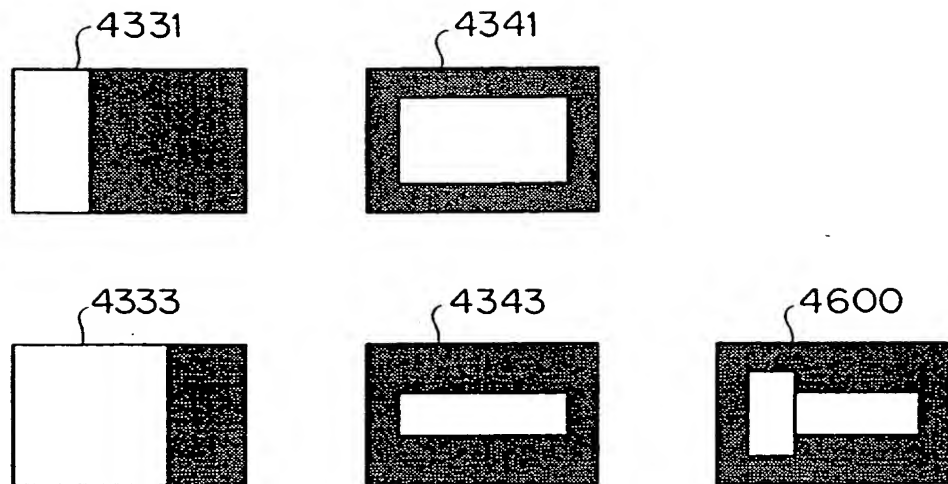


FIG. 28



4331	4333	4341	4343	4250	4260
1	—	1	—	4211	DEPTH INFORMATION ABOUT 4211
1	—	0	—	4250	4260
0	1	—	1	4211	DEPTH INFORMATION ABOUT 4211
0	1	—	0	4250	4260
0	0	—	1	4211	DEPTH INFORMATION ABOUT 4211
0	0	—	0	4250	4260

FIG. 29

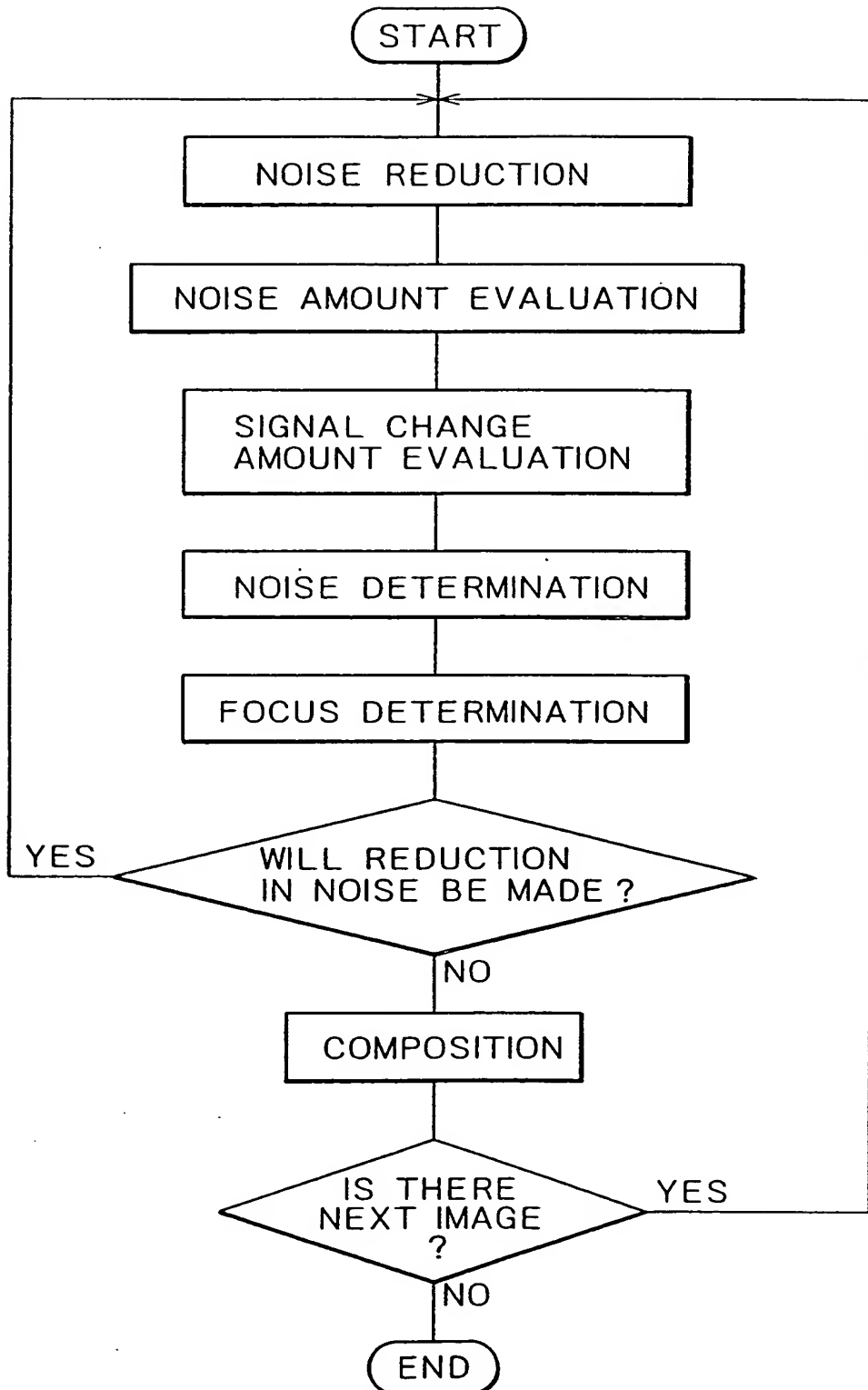


FIG. 30

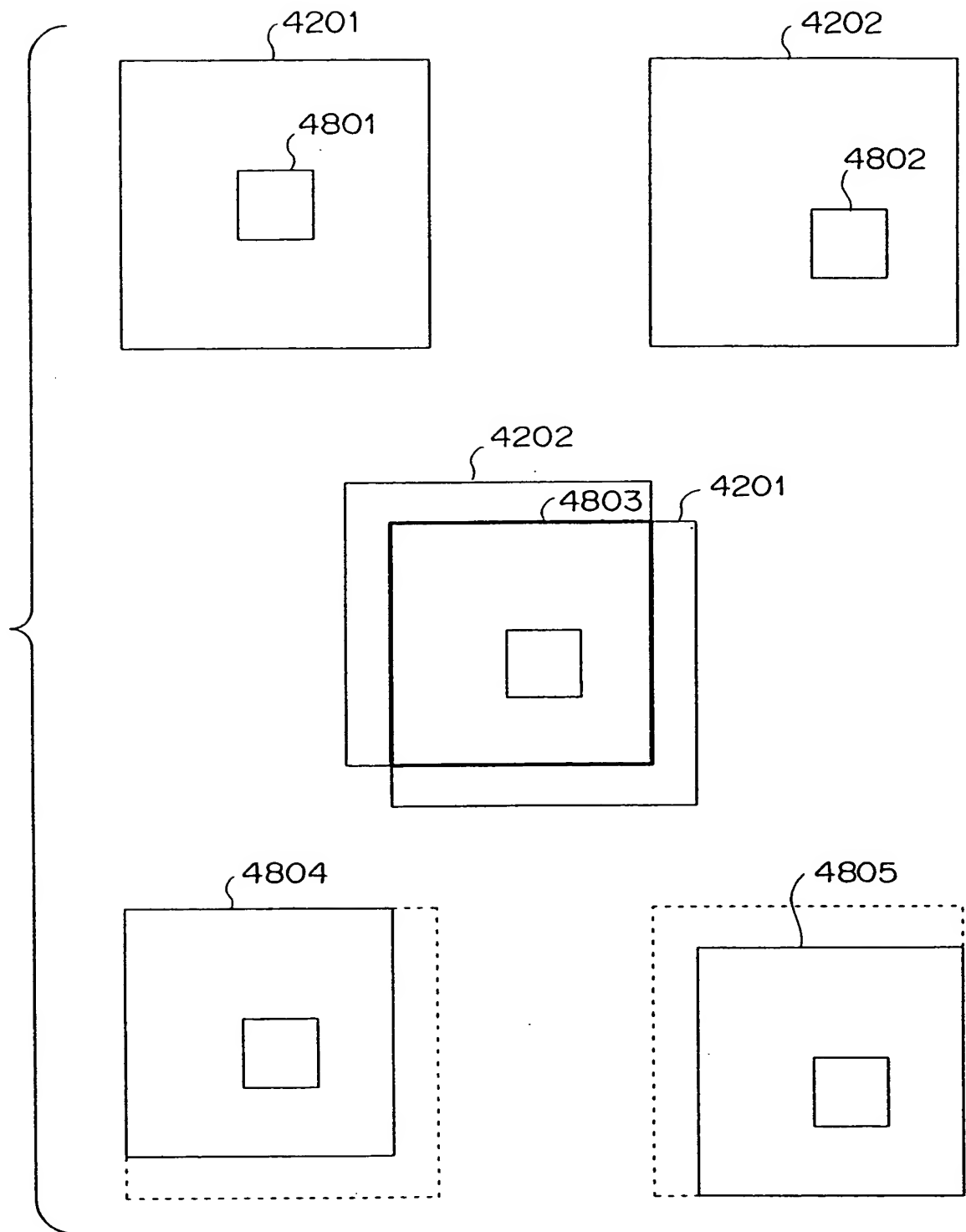


FIG. 31

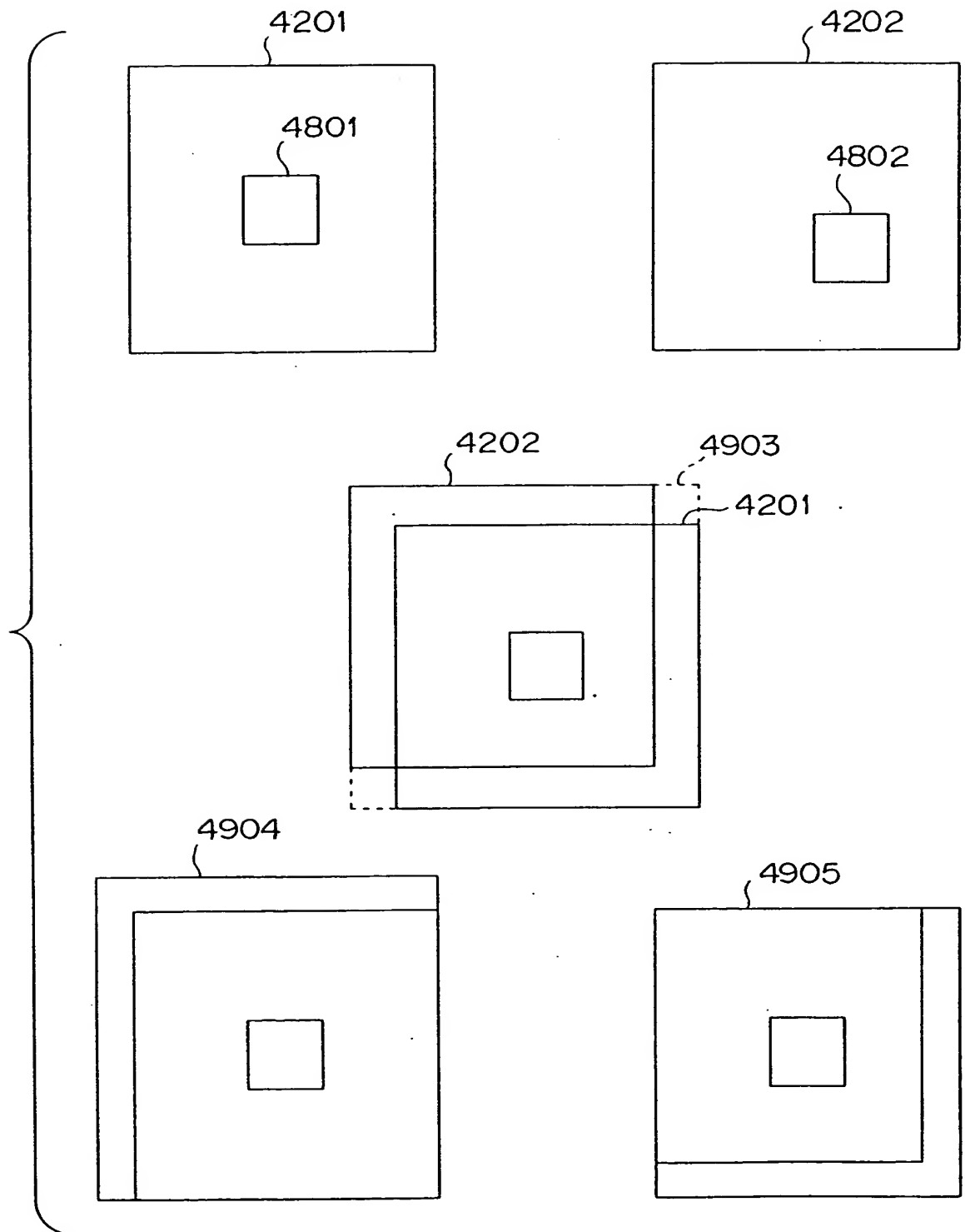


FIG. 32

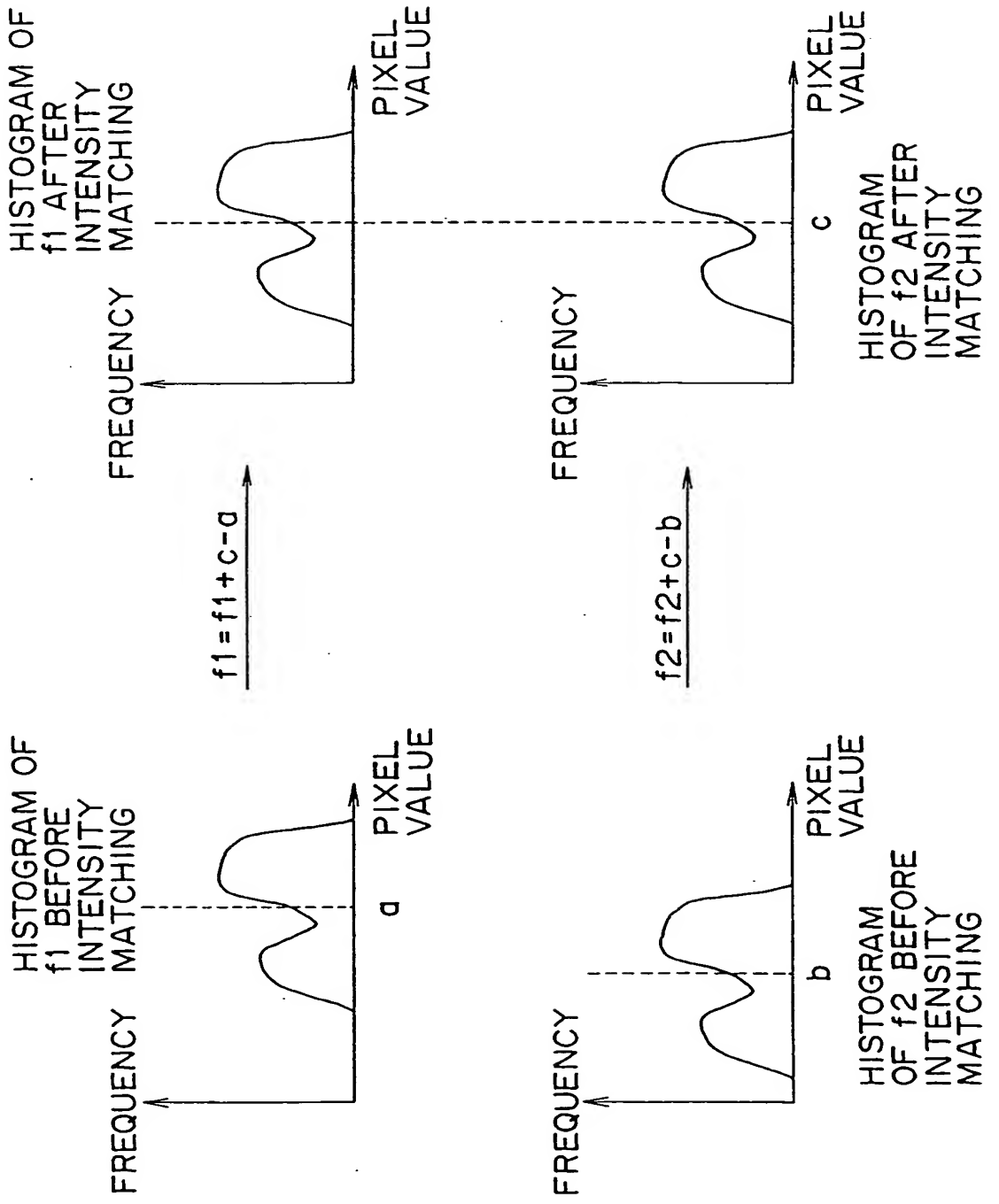


FIG. 33

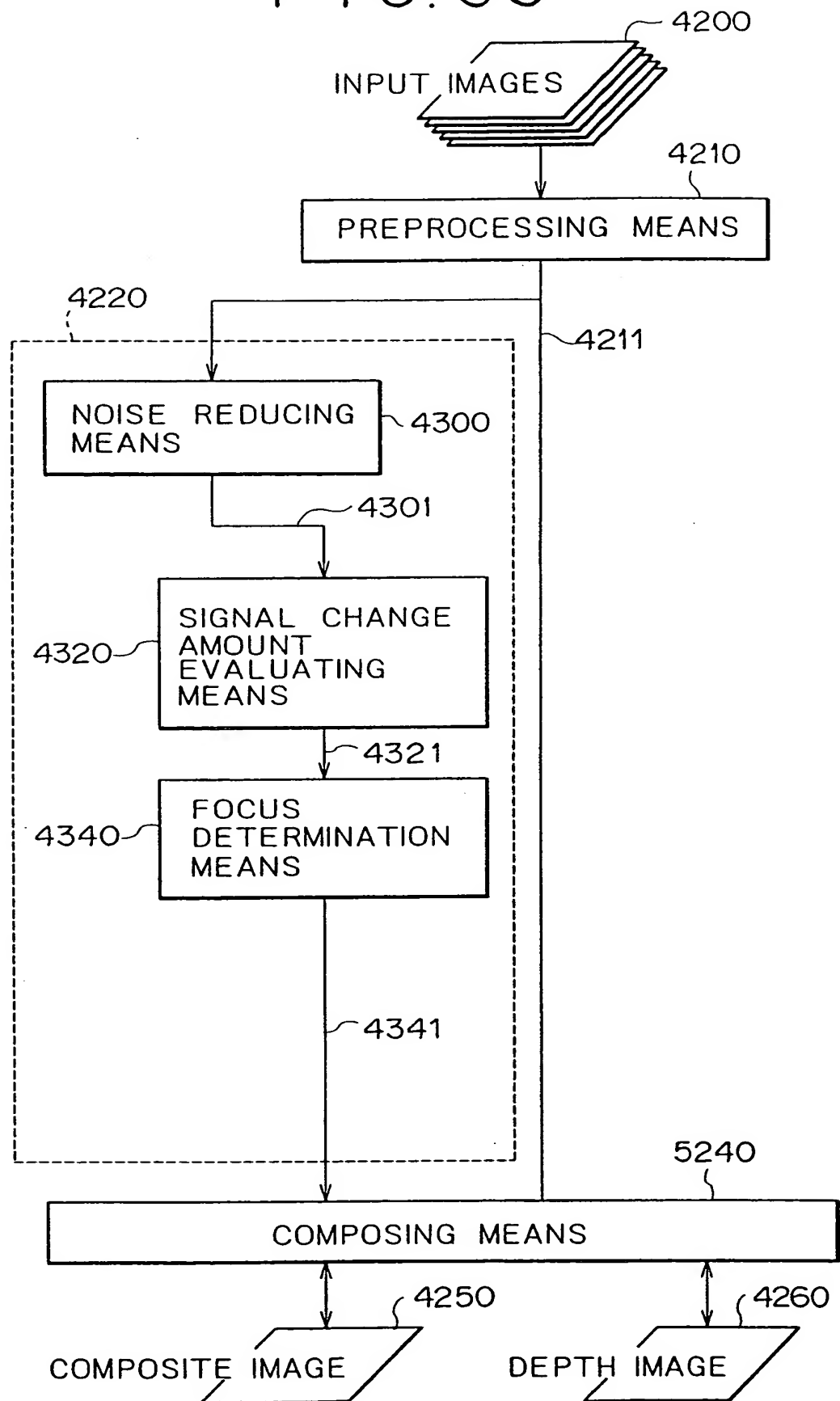


FIG. 34

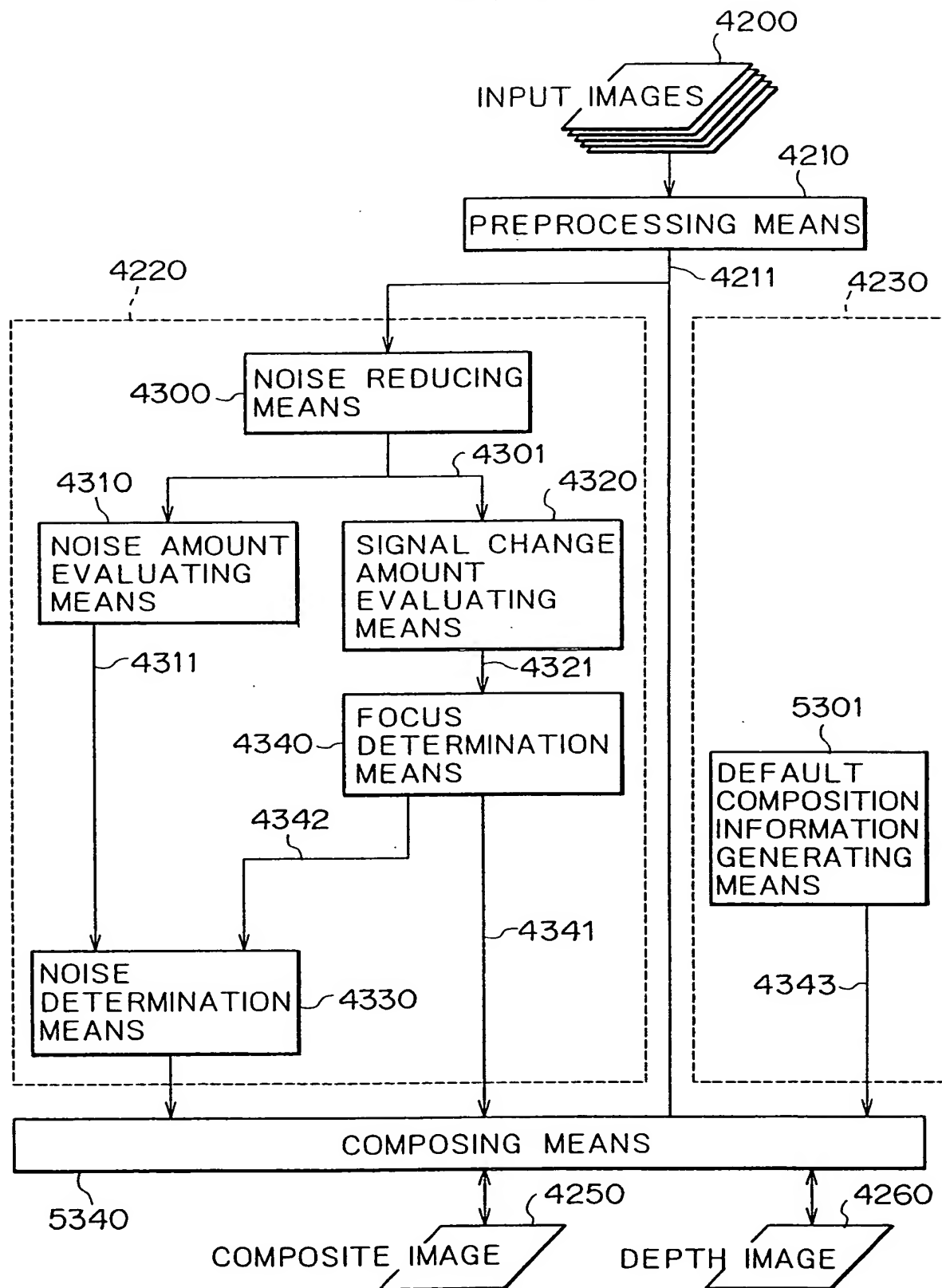


FIG. 35

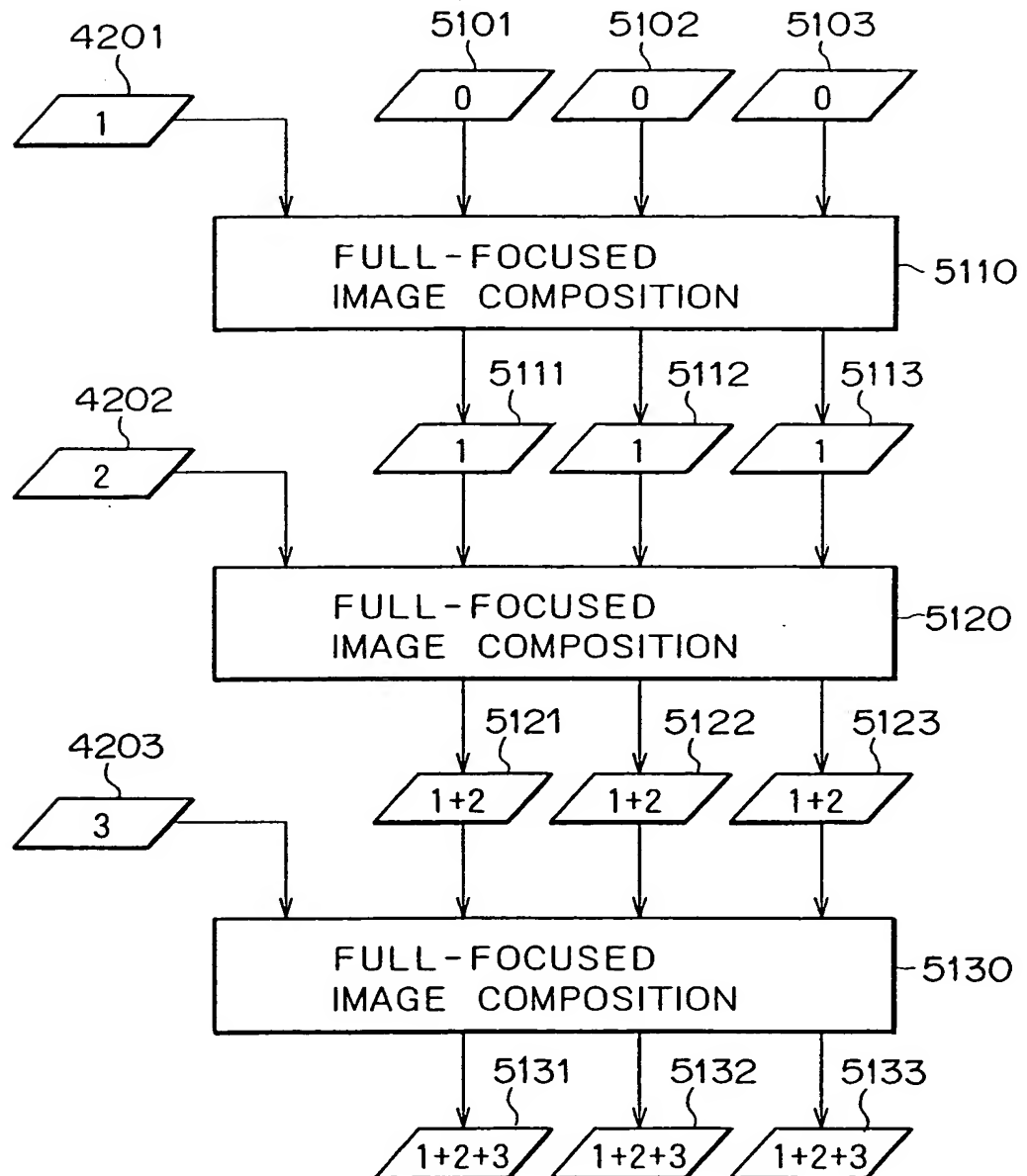


FIG. 36

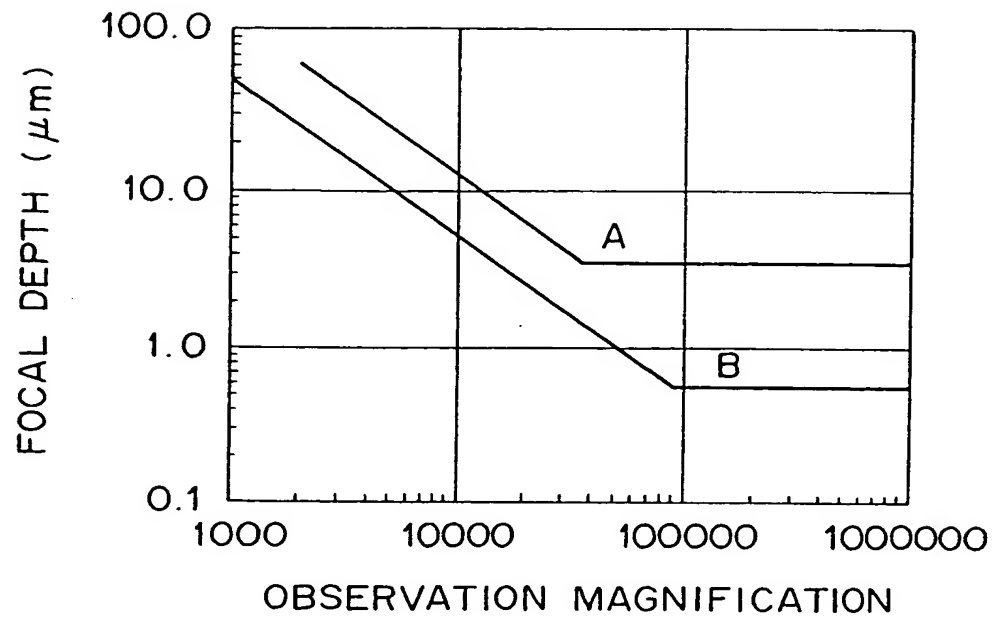


FIG. 37

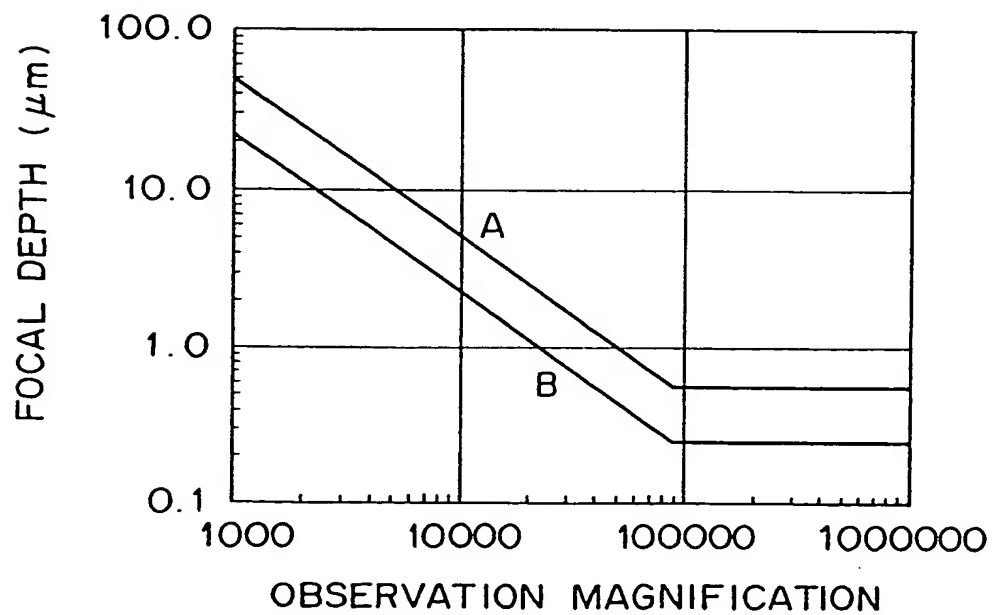


FIG. 38

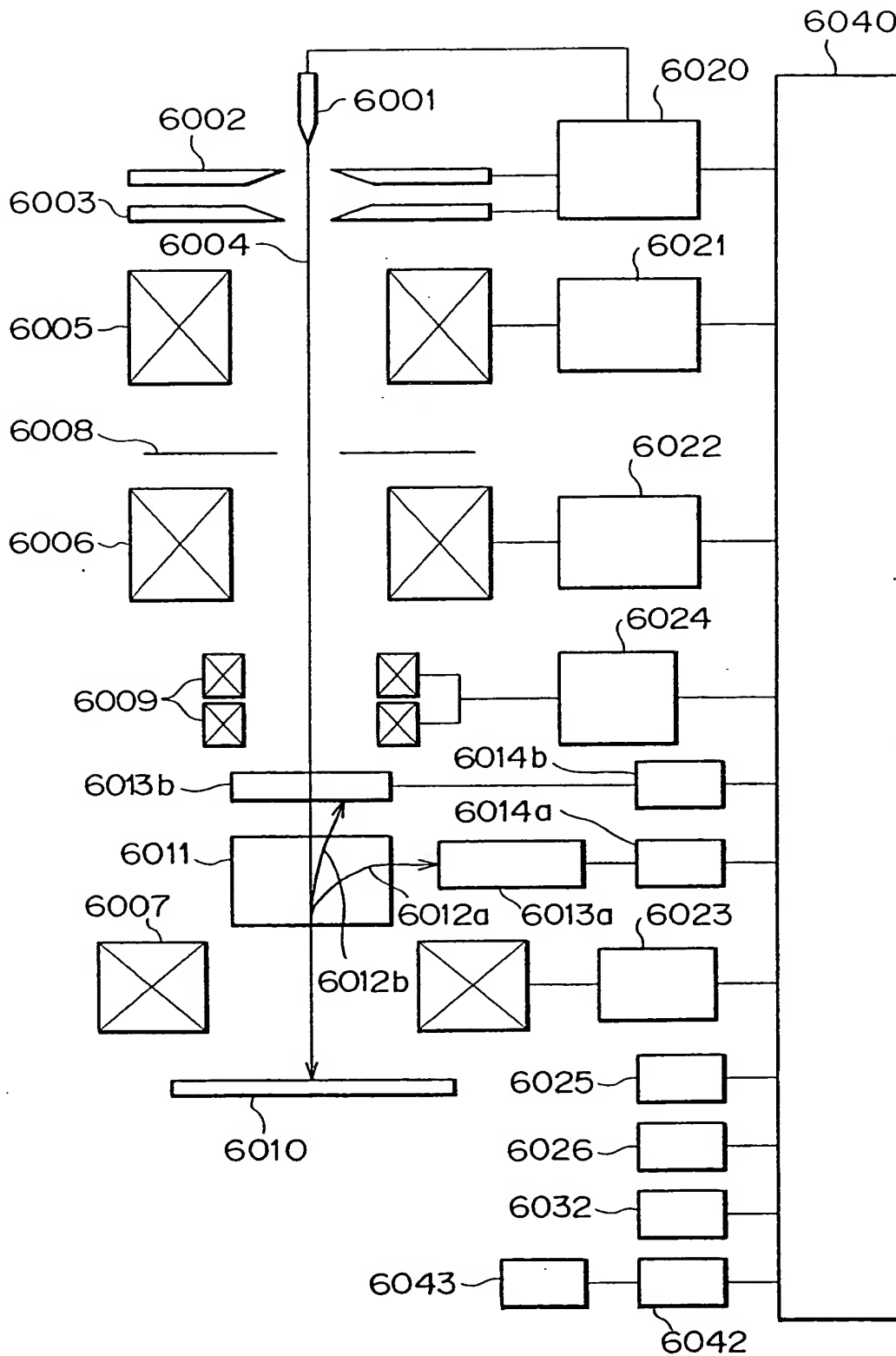


FIG. 39

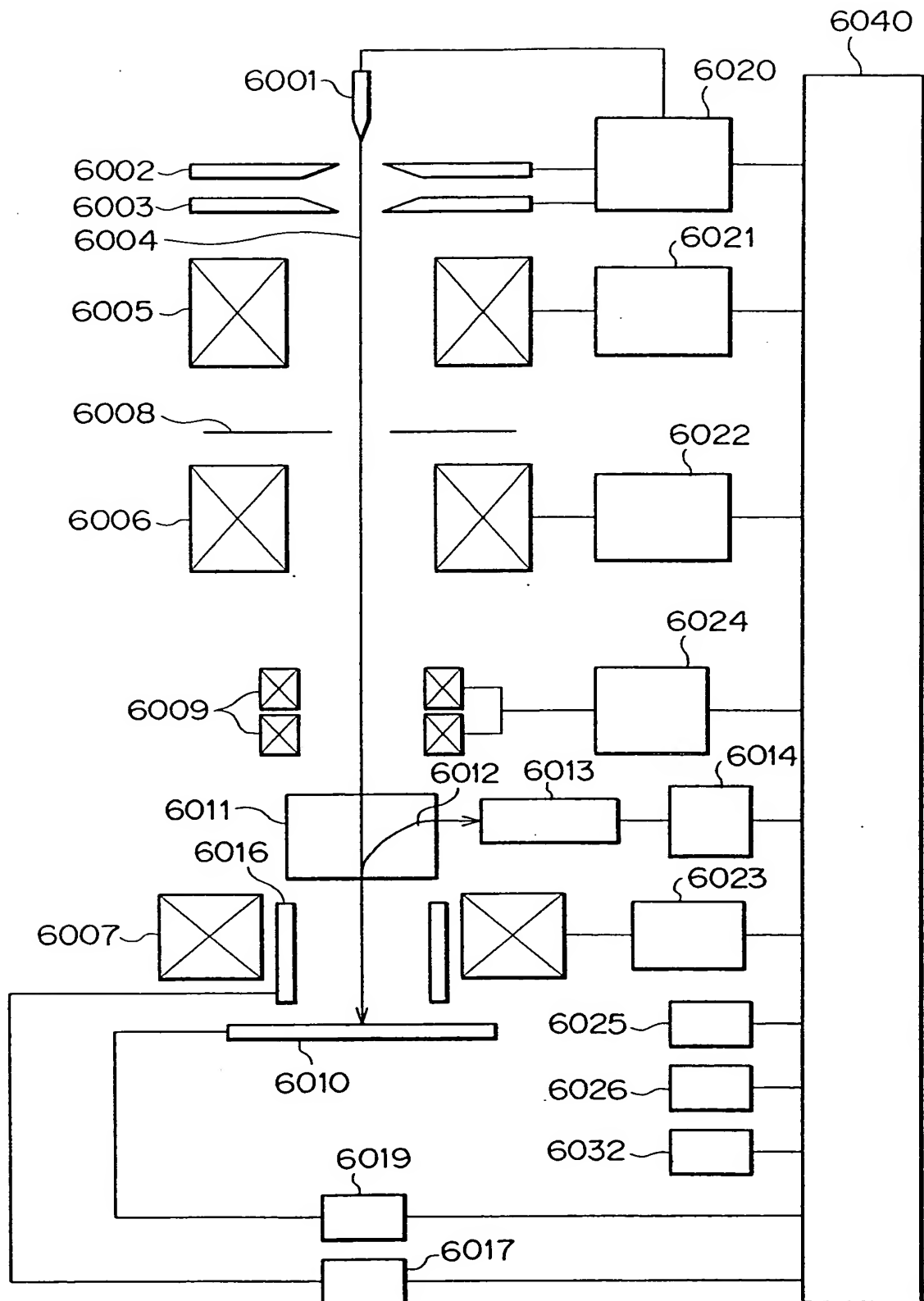


FIG. 40

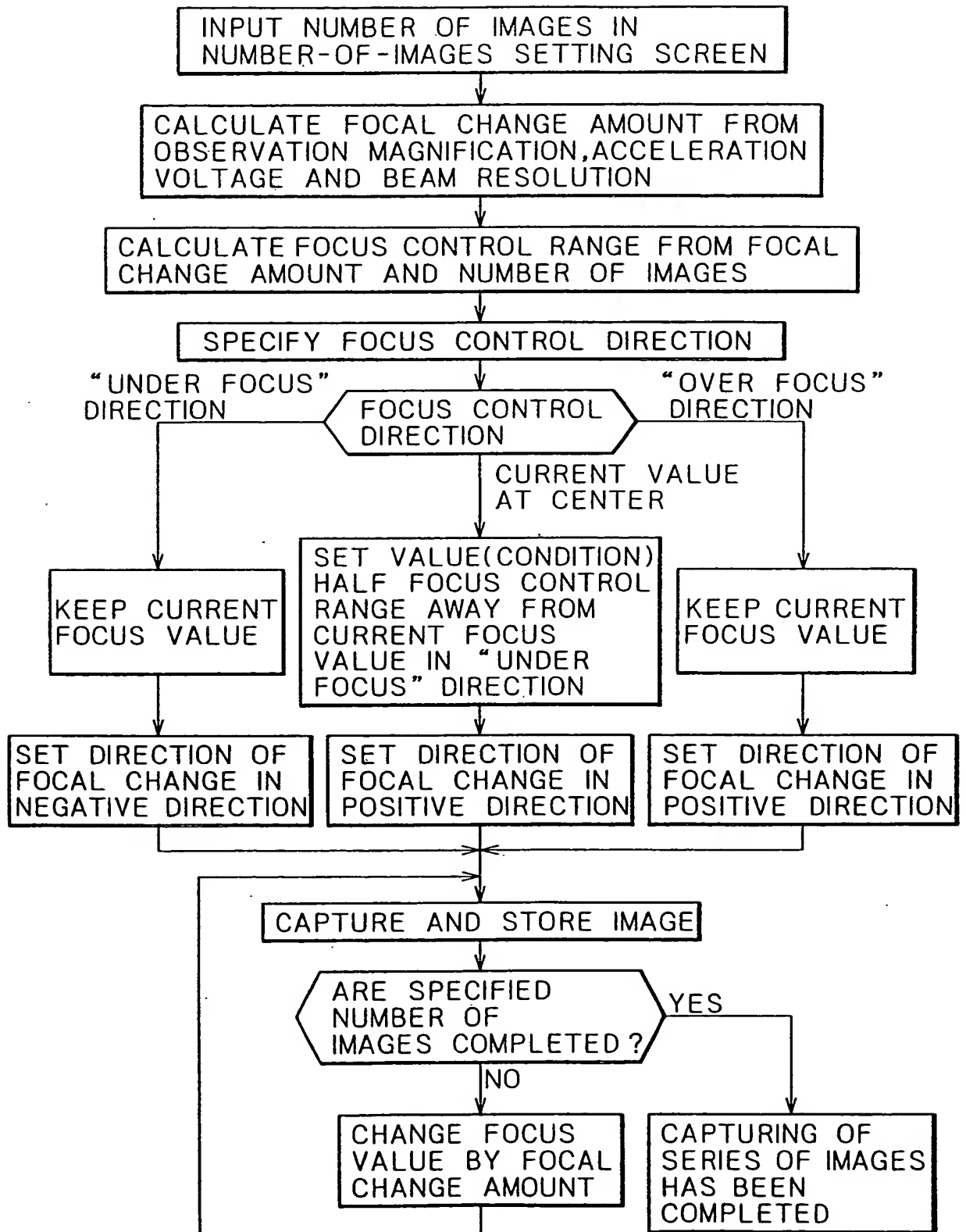


FIG. 41

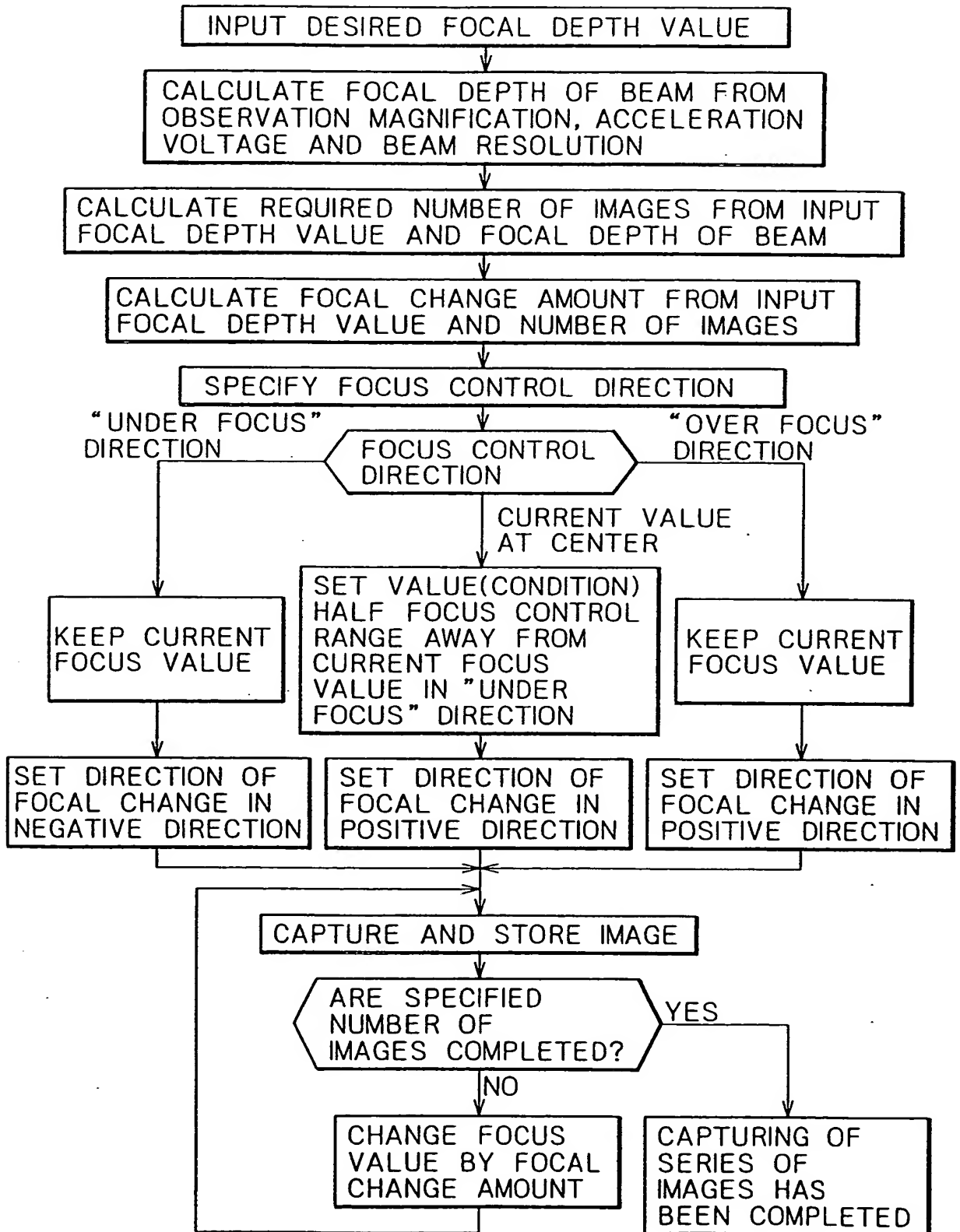


FIG. 42

